

# Calo ZS Studies

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Chi2 cut of  $\min(10^4, \text{ADC}^2/100)$

Sample 6 - Sample 0 > threshold



Energy = Template fit

Sample 6 - Sample 0  $\leq$  threshold



Energy = Sample 6 - Sample 0

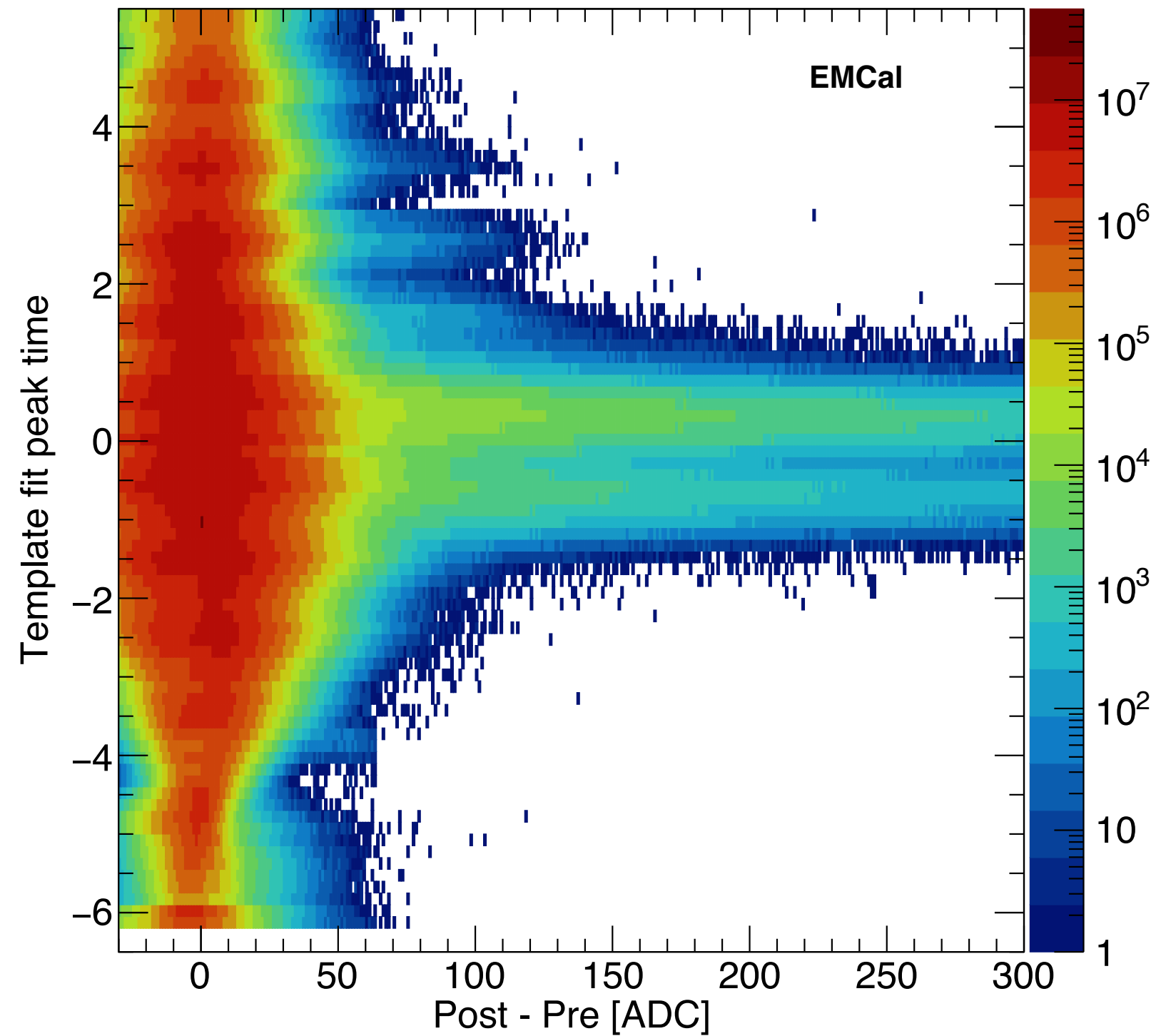
## Pedestal & threshold

- Data : Hardware ZS on DCM2 account for 2 sigma of ped. fluctuation in beam data
- MC : Embedded ped. fluctuation from No beam + bias on data without zero suppression
  - Currently a uniform ZS threshold cut applied — plan to load ch-by-ch tuned zs thresholds

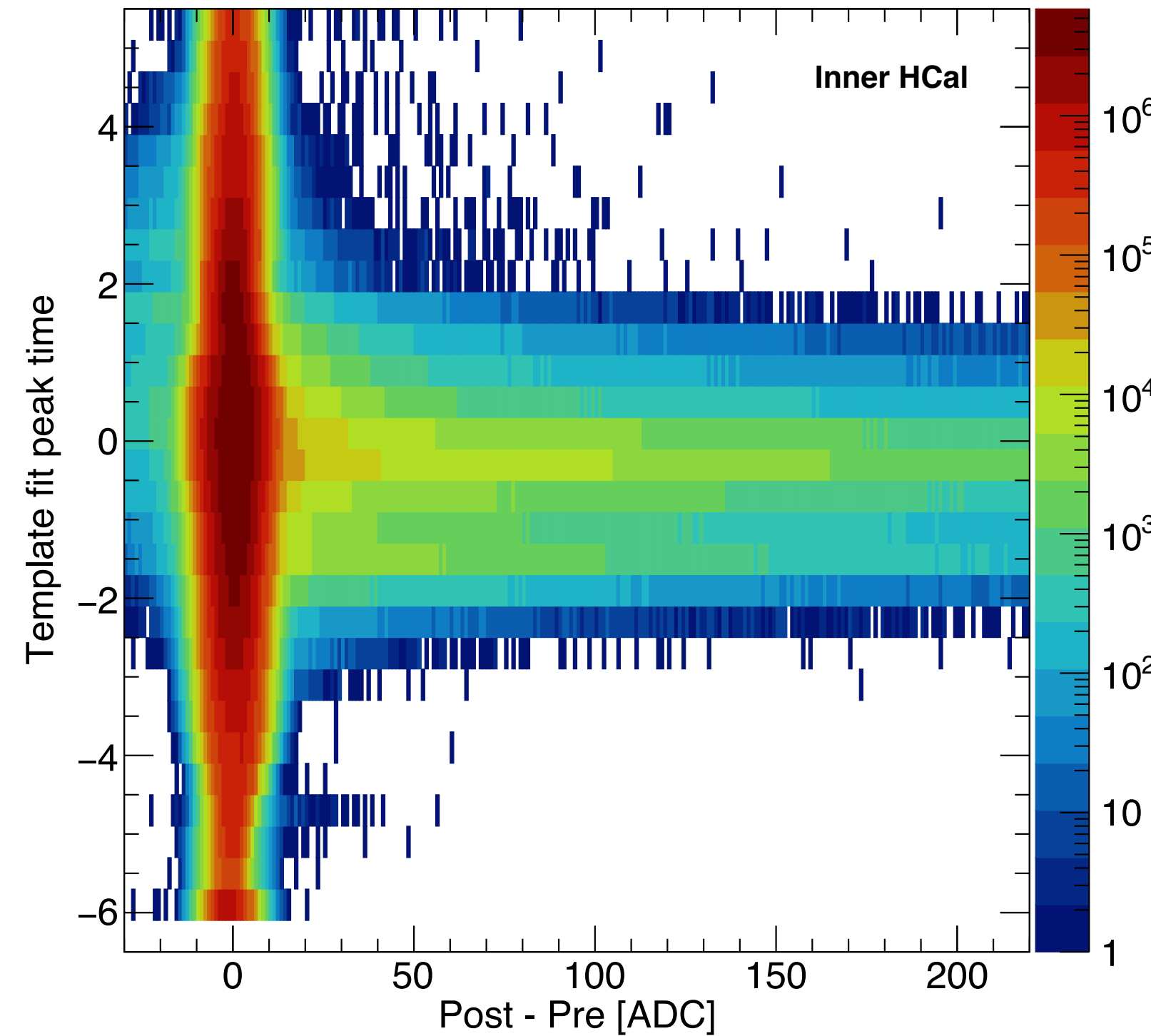
## Why does this matter?

- Template fit is known to have a “positive bias” + “higher” value than Post-Pre (Sample 6 -Sample 0)
- Hardware ZS is not optimized for ‘*all of the noise*’ but to effectively reject noise to secure bandwidth
- Is the threshold high enough to ensure no bias on tower energies
  - No energy correction on Post-Pre applied at the moment
  - Even ~1 ADC positive bias per tower  $\rightarrow$  GeV level shift in a R=0.4 jet

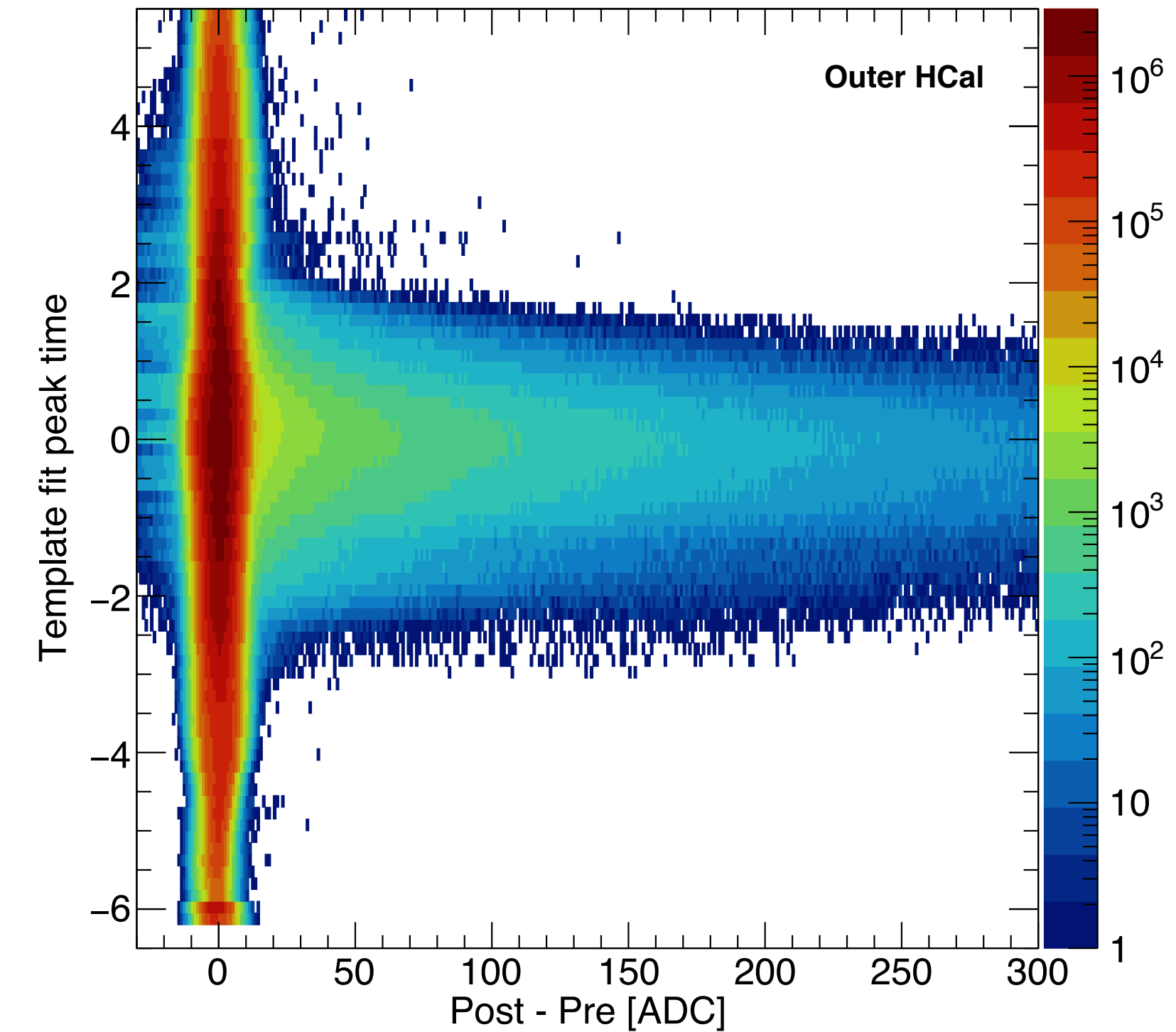
SPHENIX Internal pp  $\sqrt{s}$  = 200 GeV, Run 44060 (400k events)



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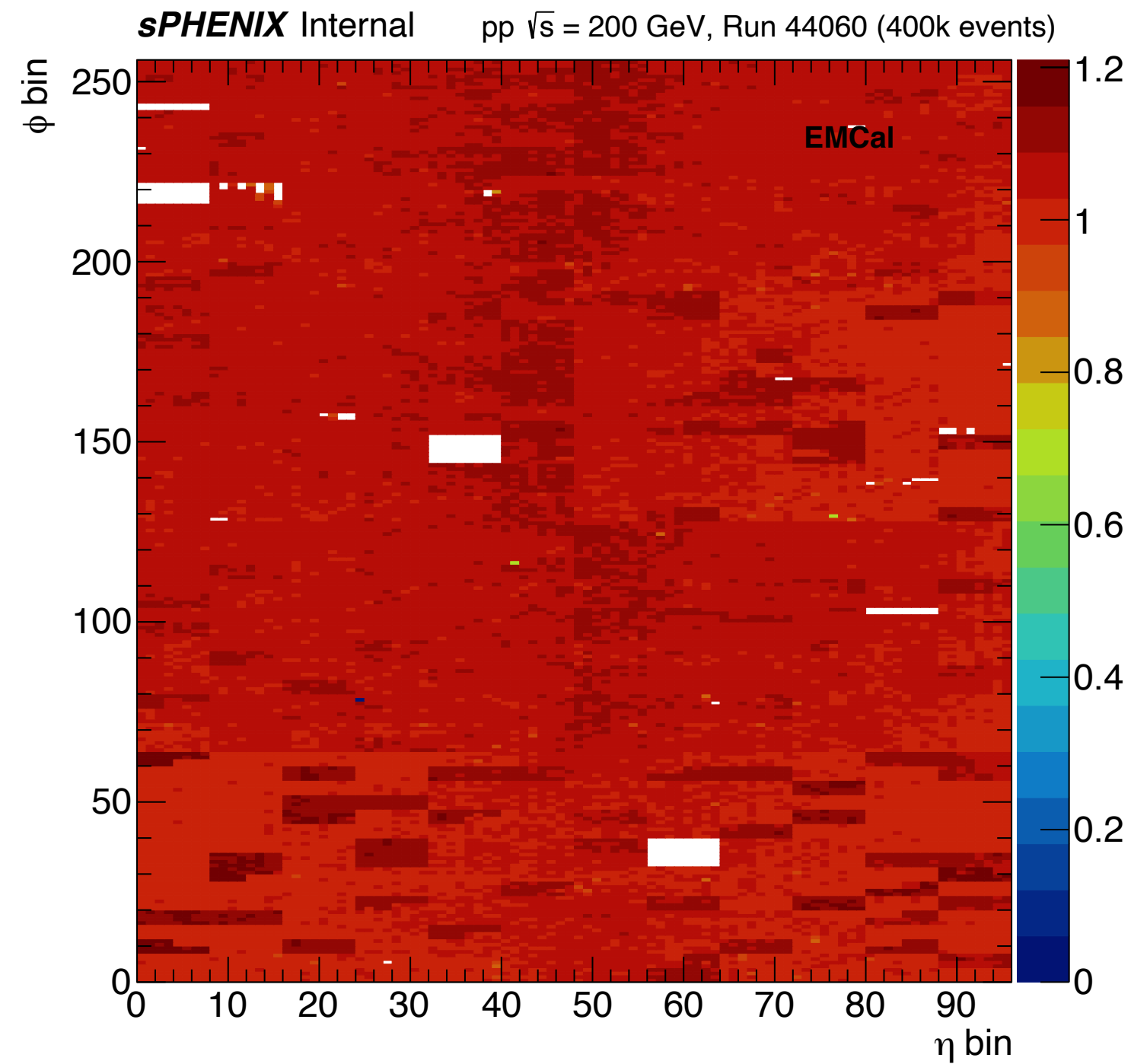


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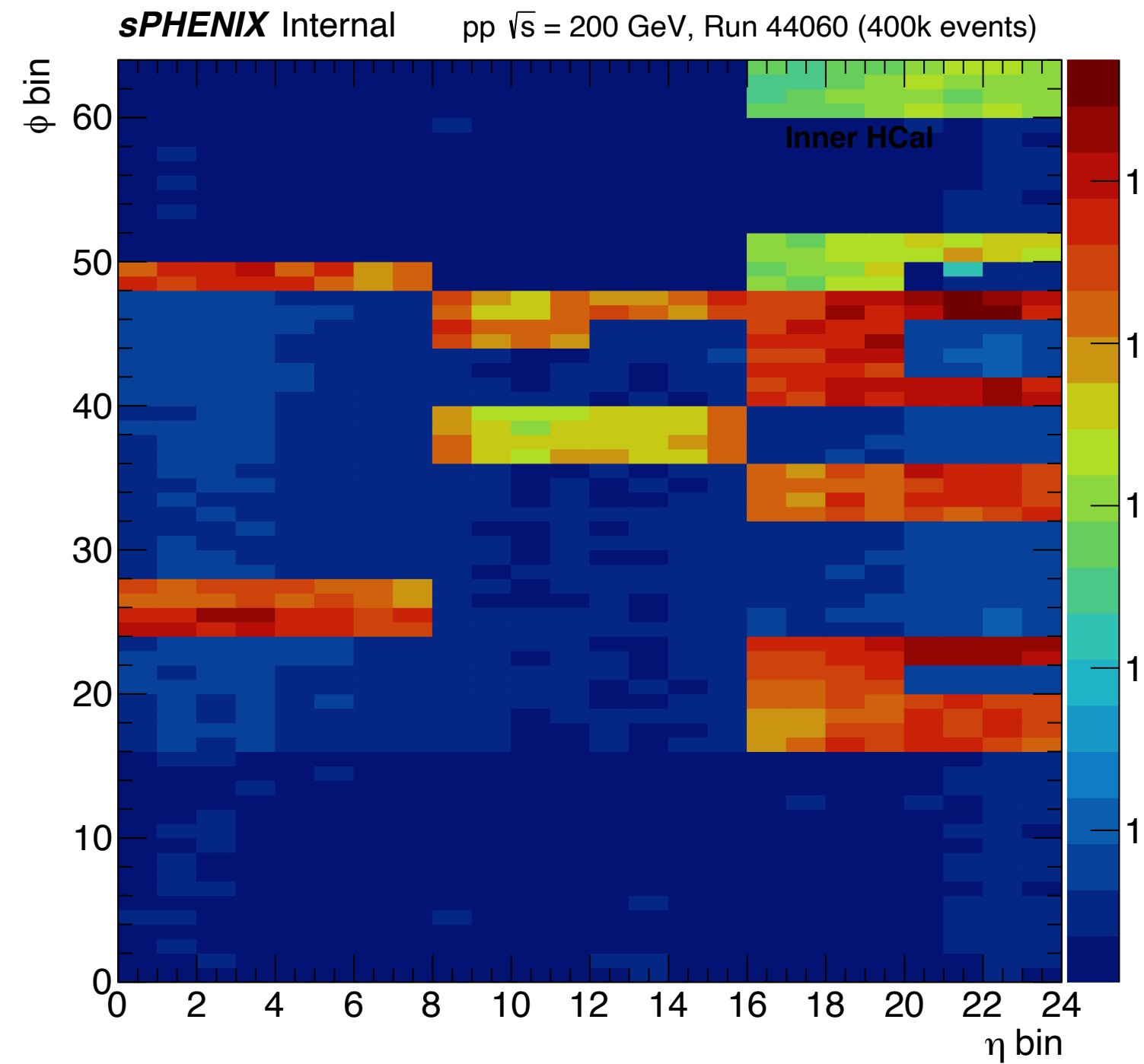


- Post - Pre vs Template Fit peak time position
- Wide out of time events in emcal even for ~50 ADC threshold

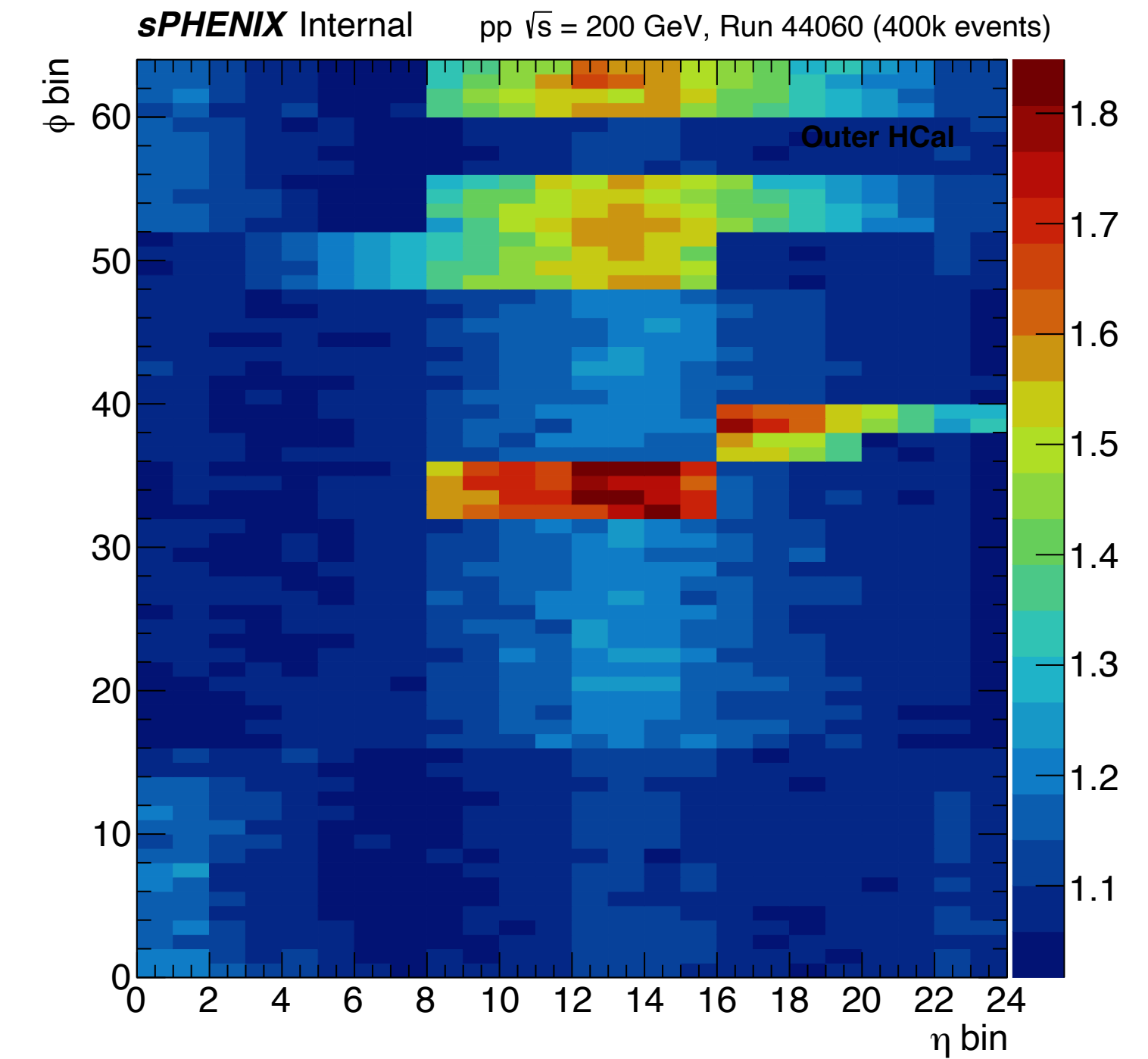
## EMCal



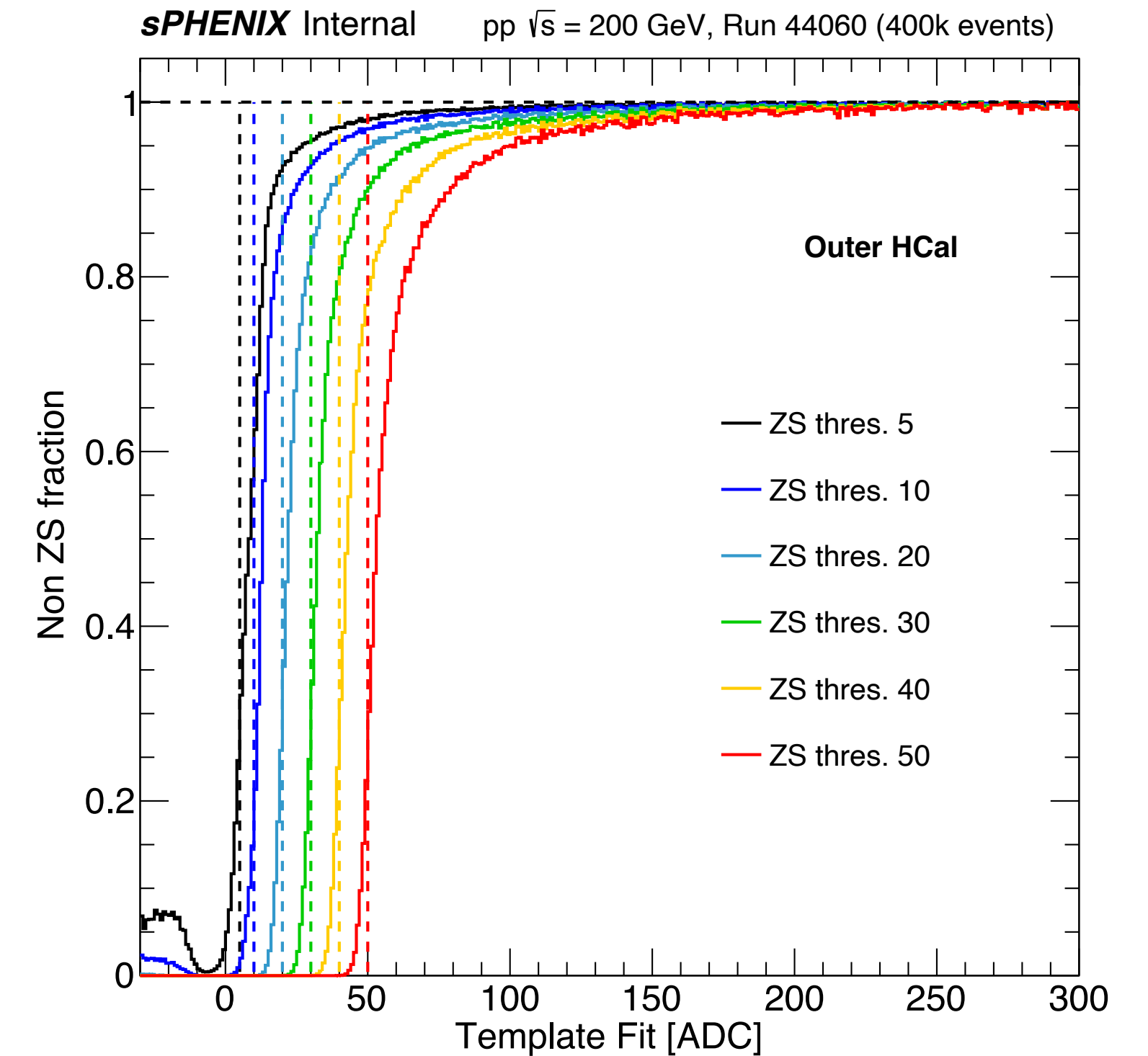
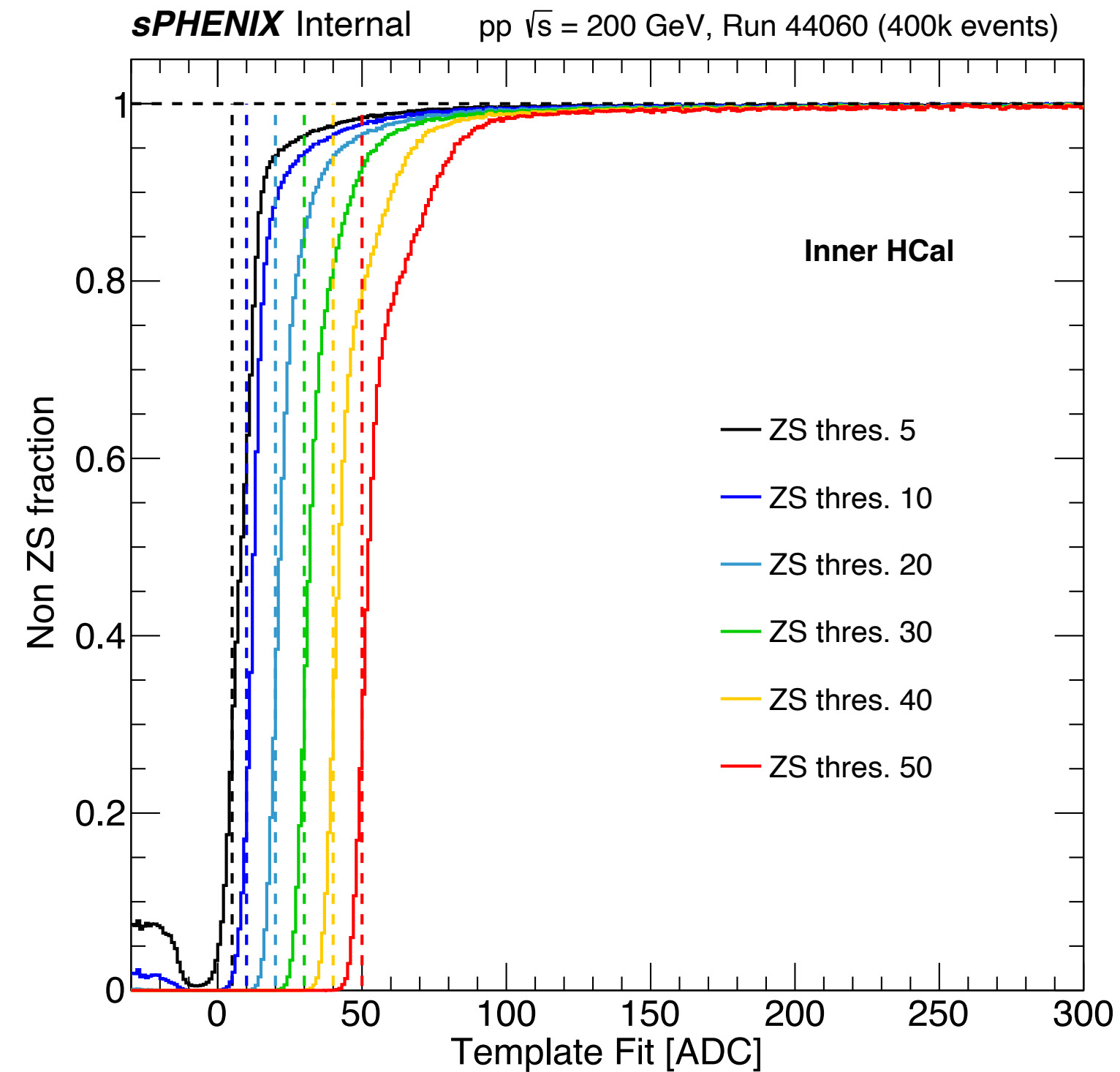
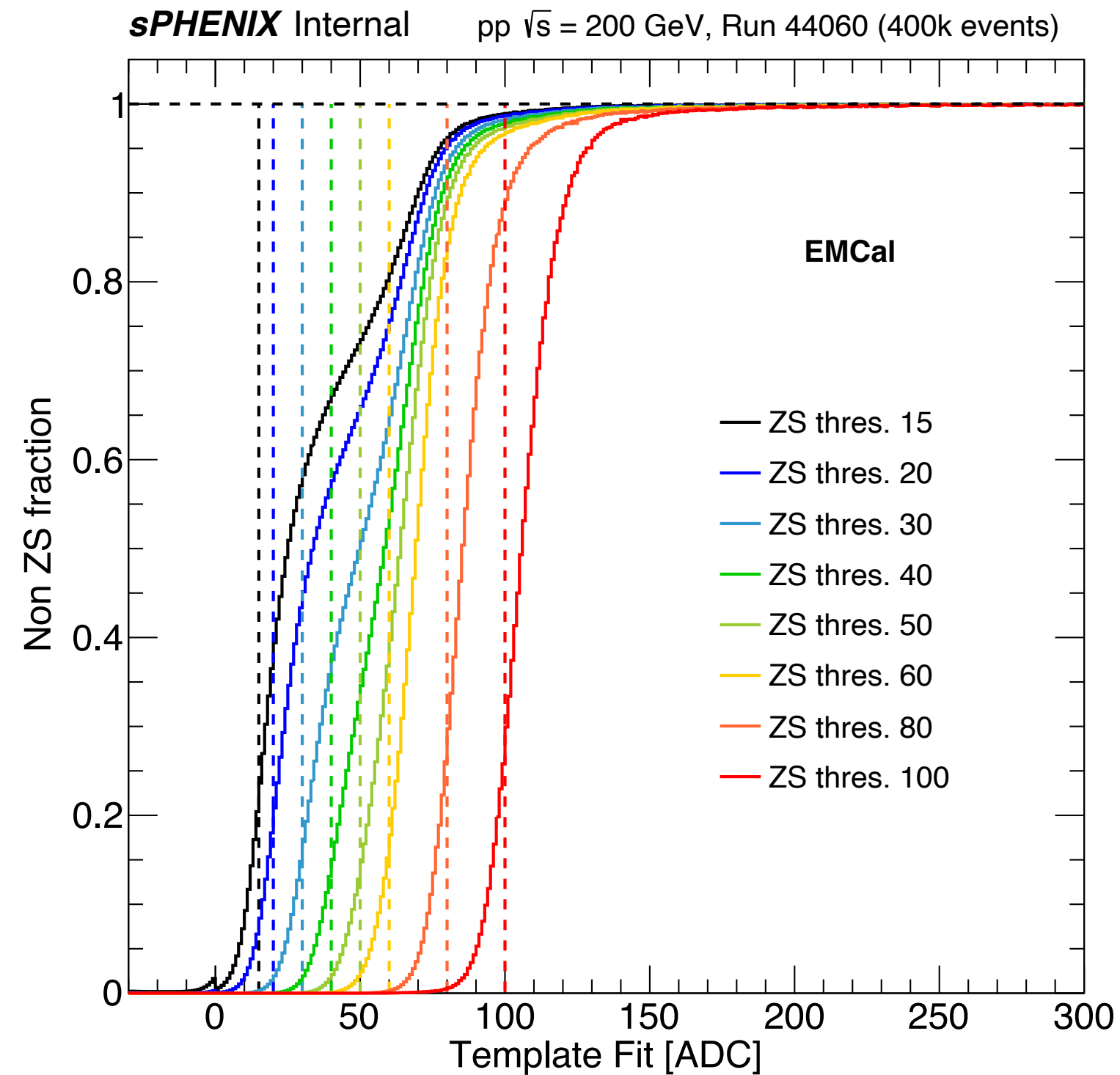
## Inner HCal



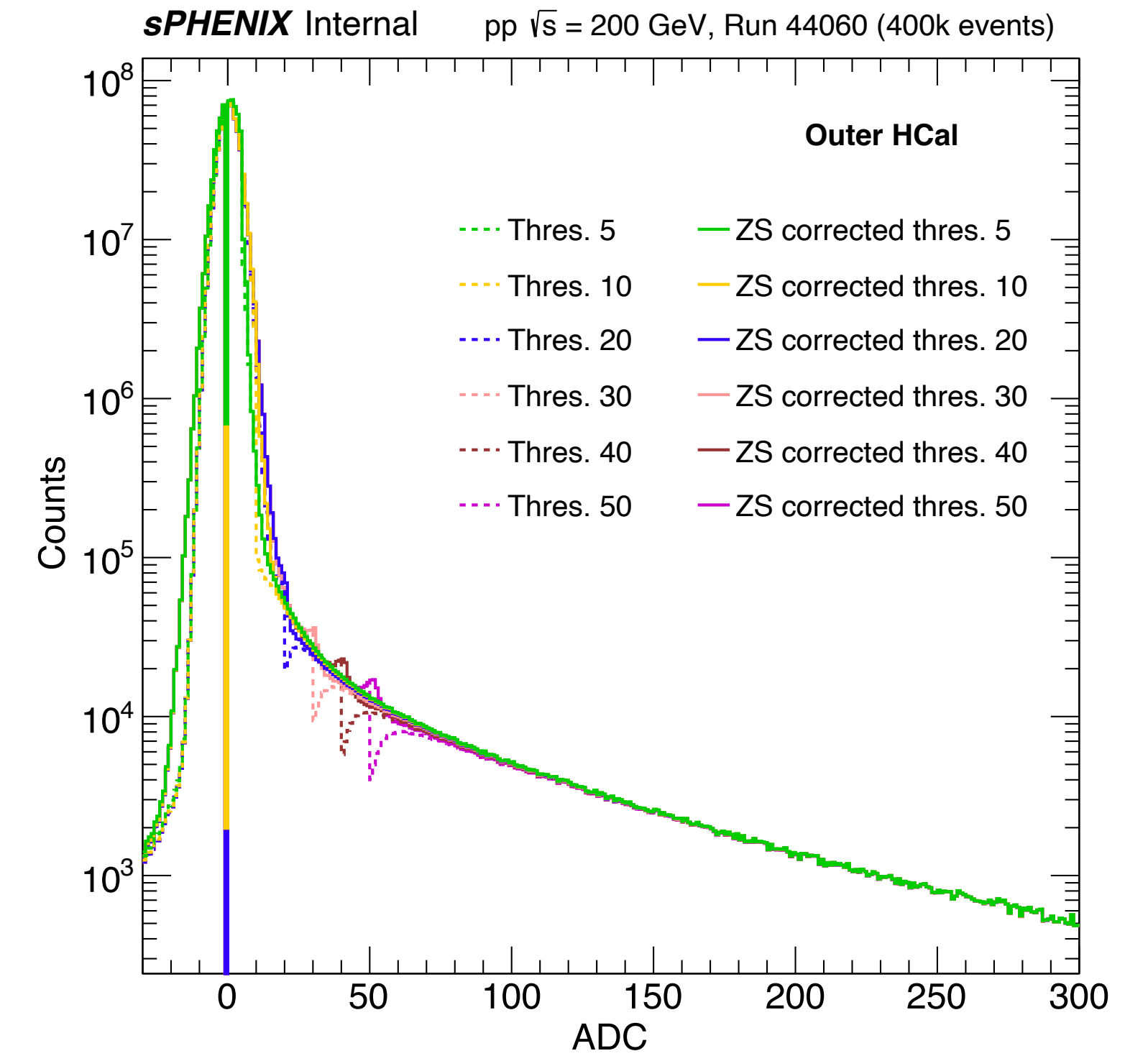
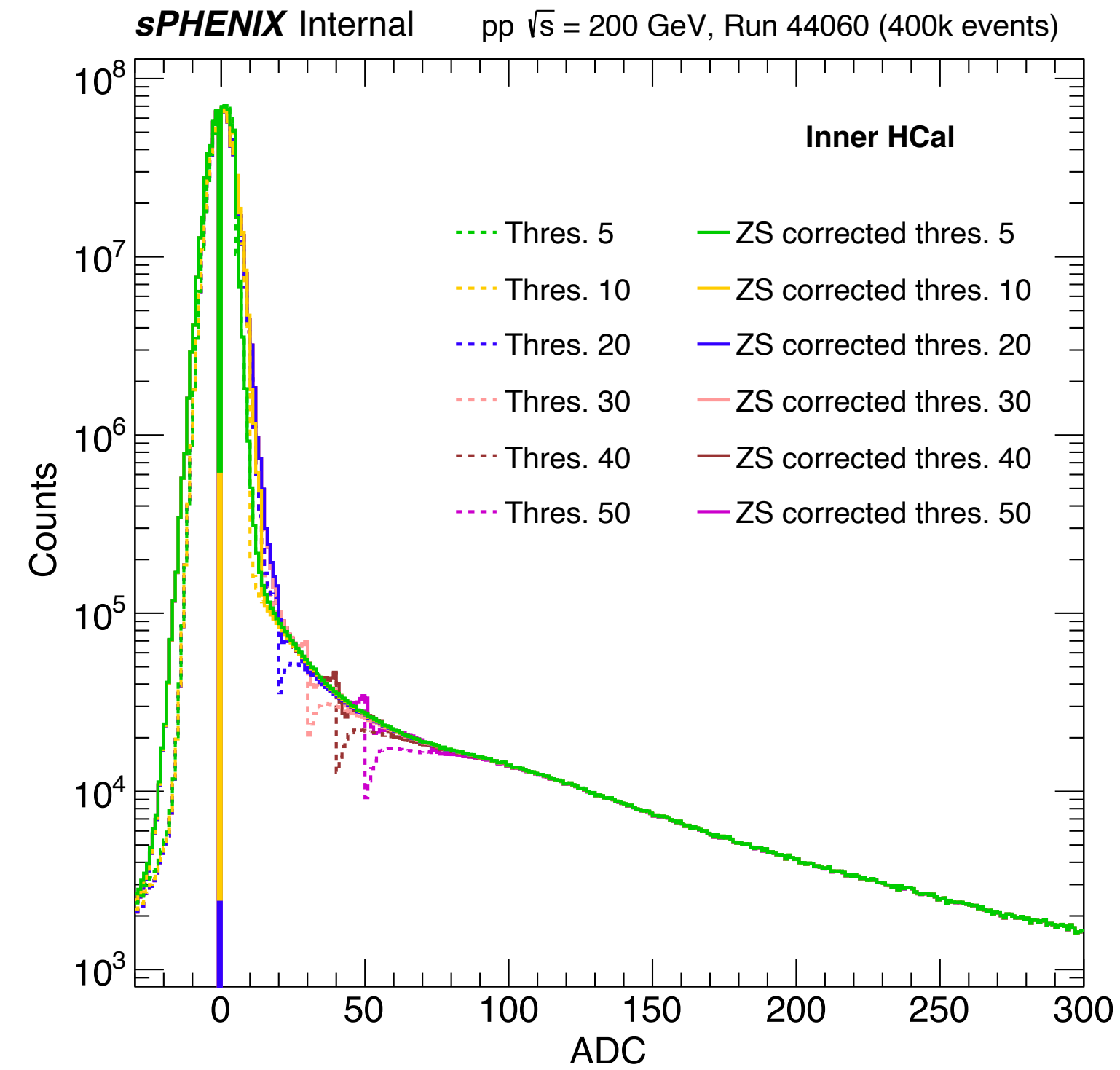
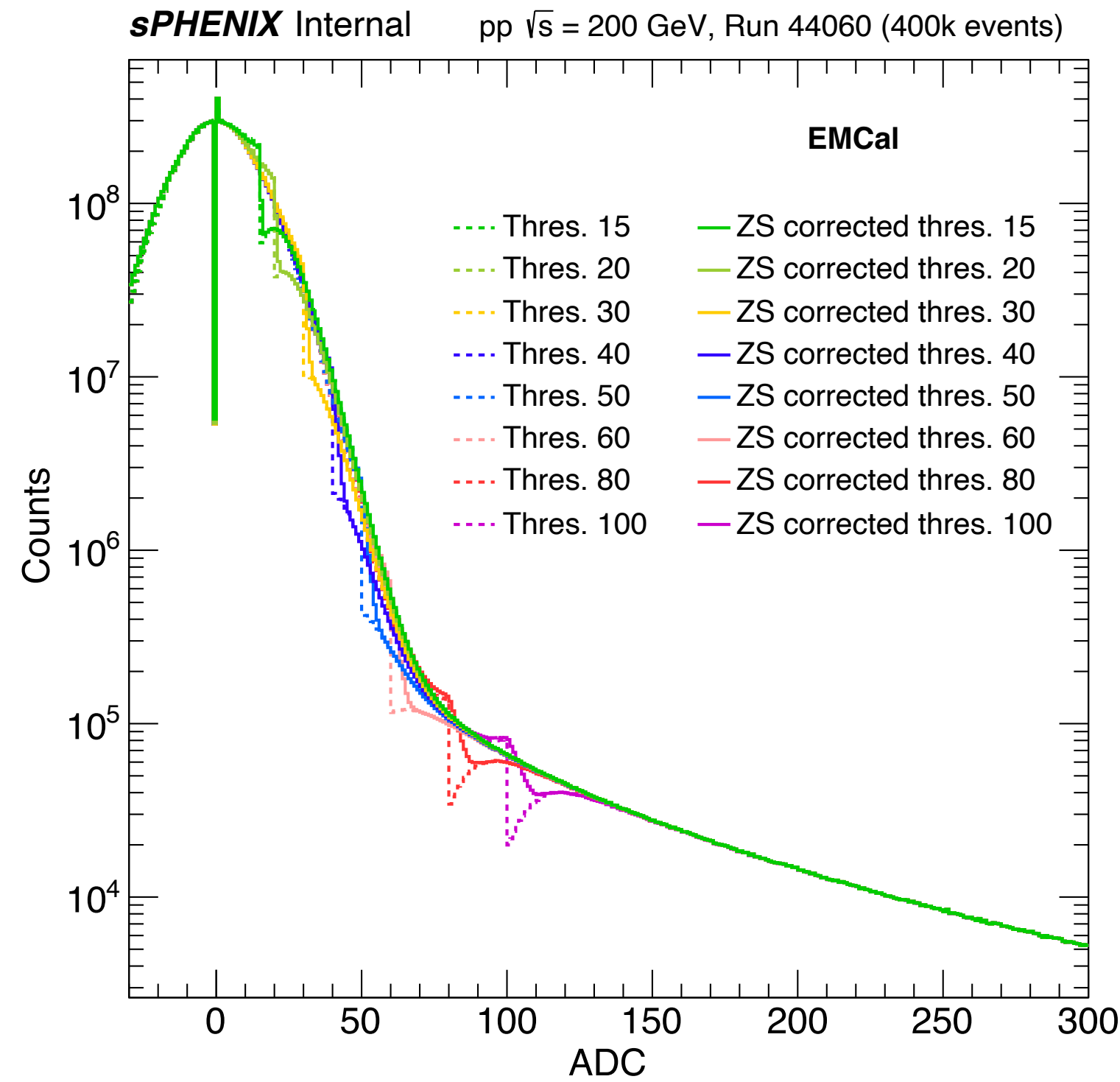
## Outer HCal



- Template / post-pre for post-pre ADC > 60
- Overall higher energy values for template fit than post-pre

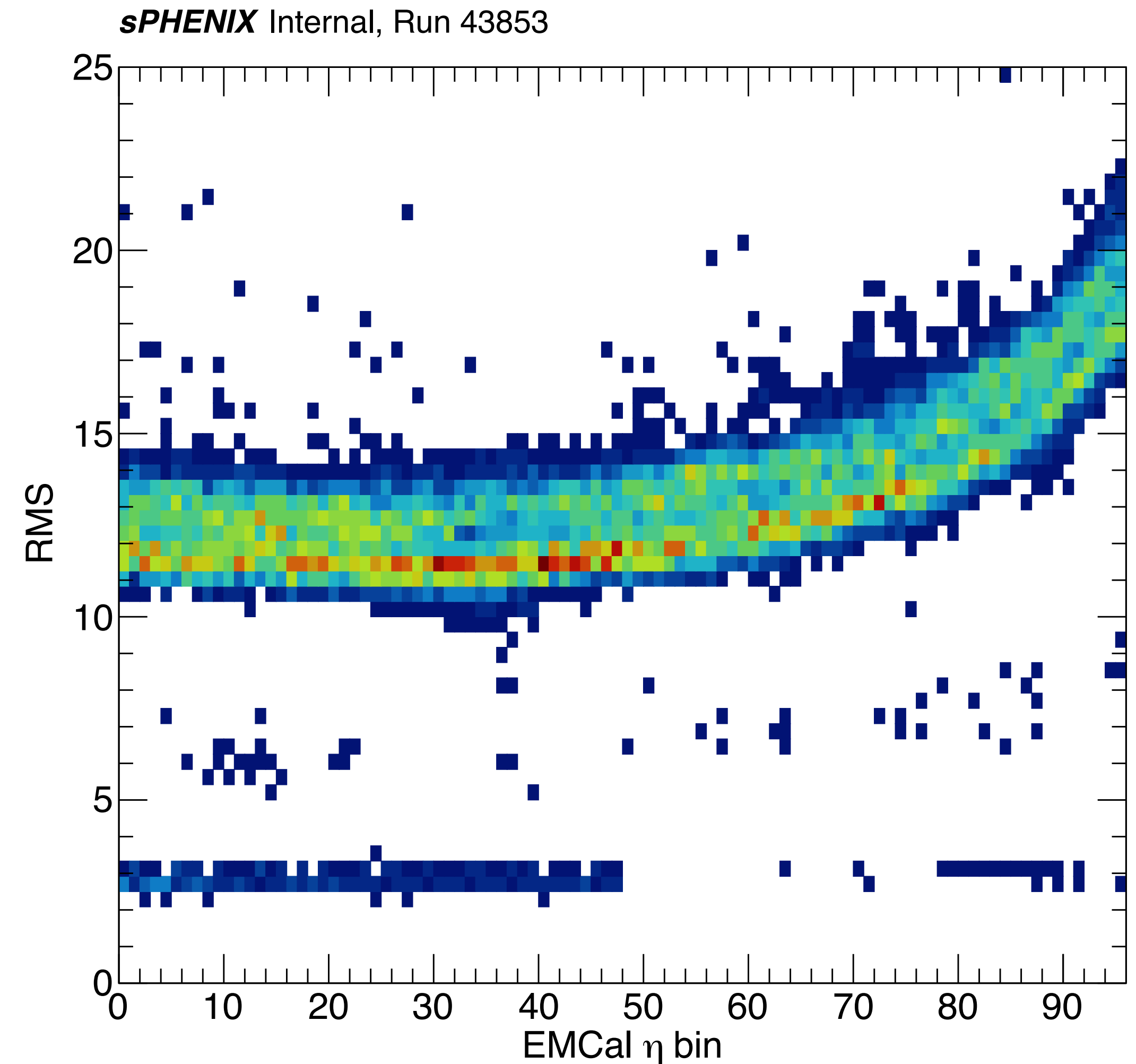


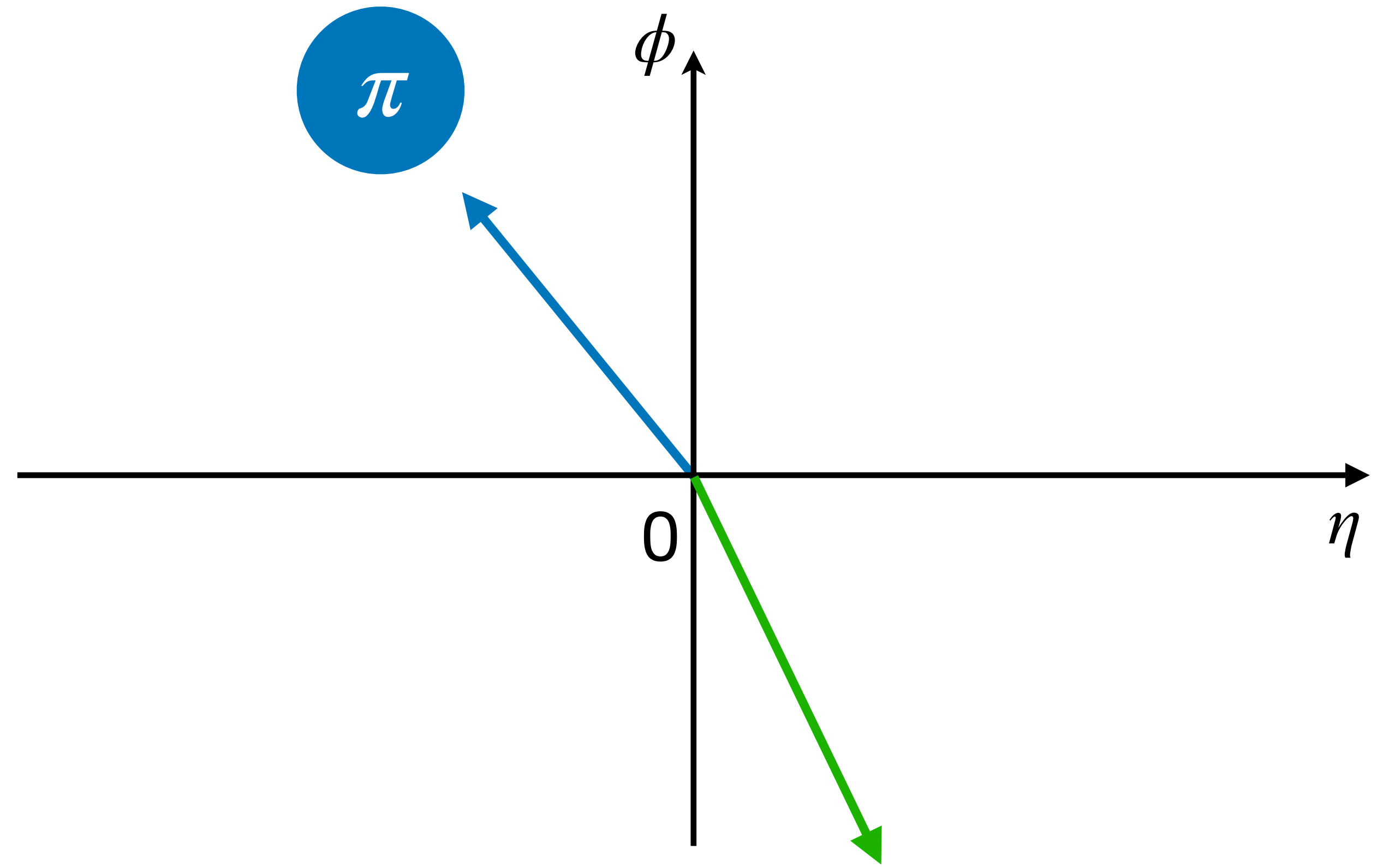
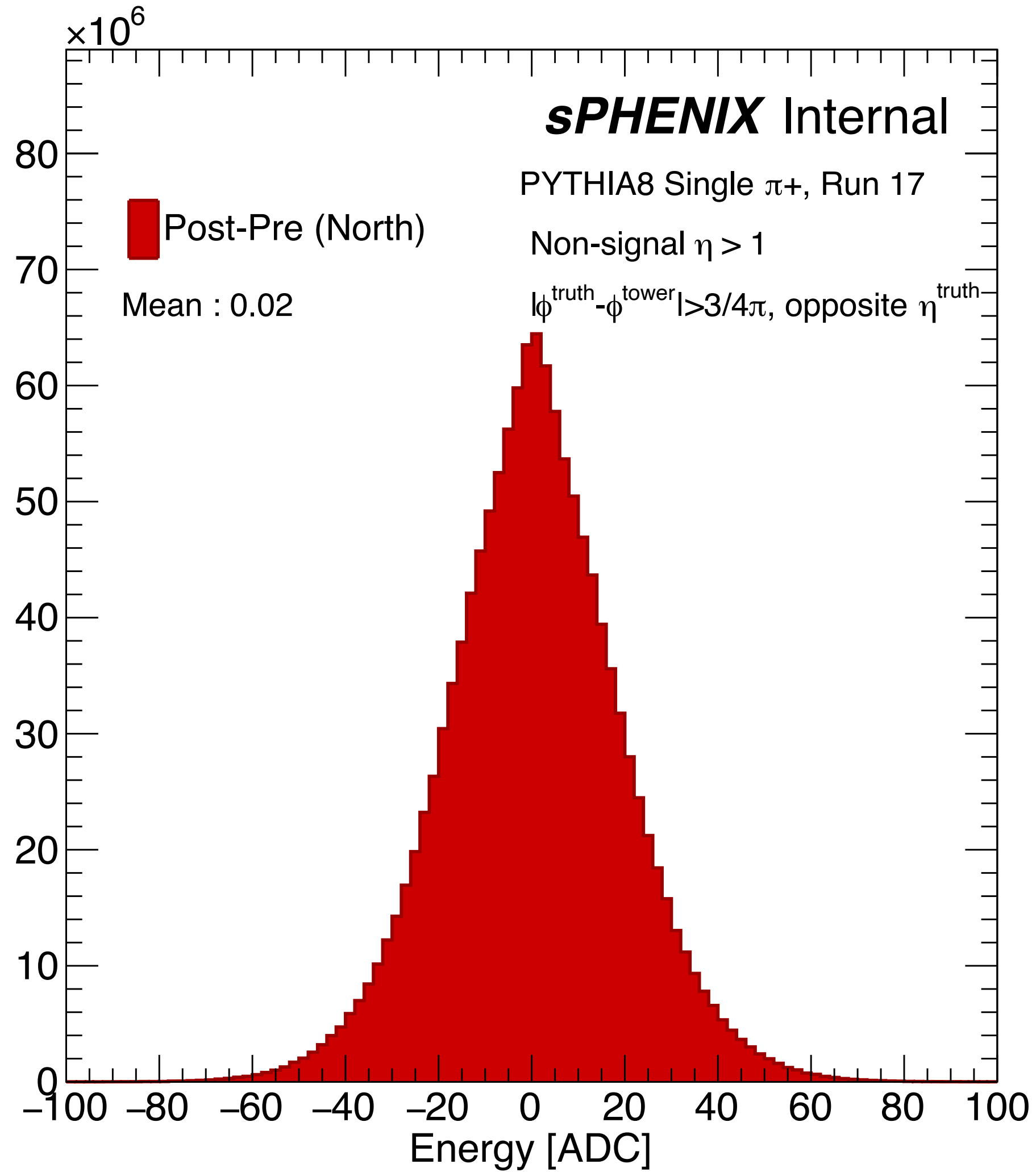
- Fraction of non zero-suppressed towers vs template fit ADC
- Smearing effect causing a turn-on curve shape in ZS fraction vs template fit
- Smooth turn on > 60 ADC ZS threshold in EMCal (30 seems enough for HCal)



- ZS energy corrected based on higher energy template fit results
- Bump near threshold — could be still smearing effect / different cross calibration factors for lower energies

- Data-driven RMS varying vs eta up to ~20 ADC counts
- Consistent with no beam + bias on results
- MC CaloWaveform :  
Pedestal fluctuations emulated with embedding to  
no beam + bias voltage on data w/o ZS

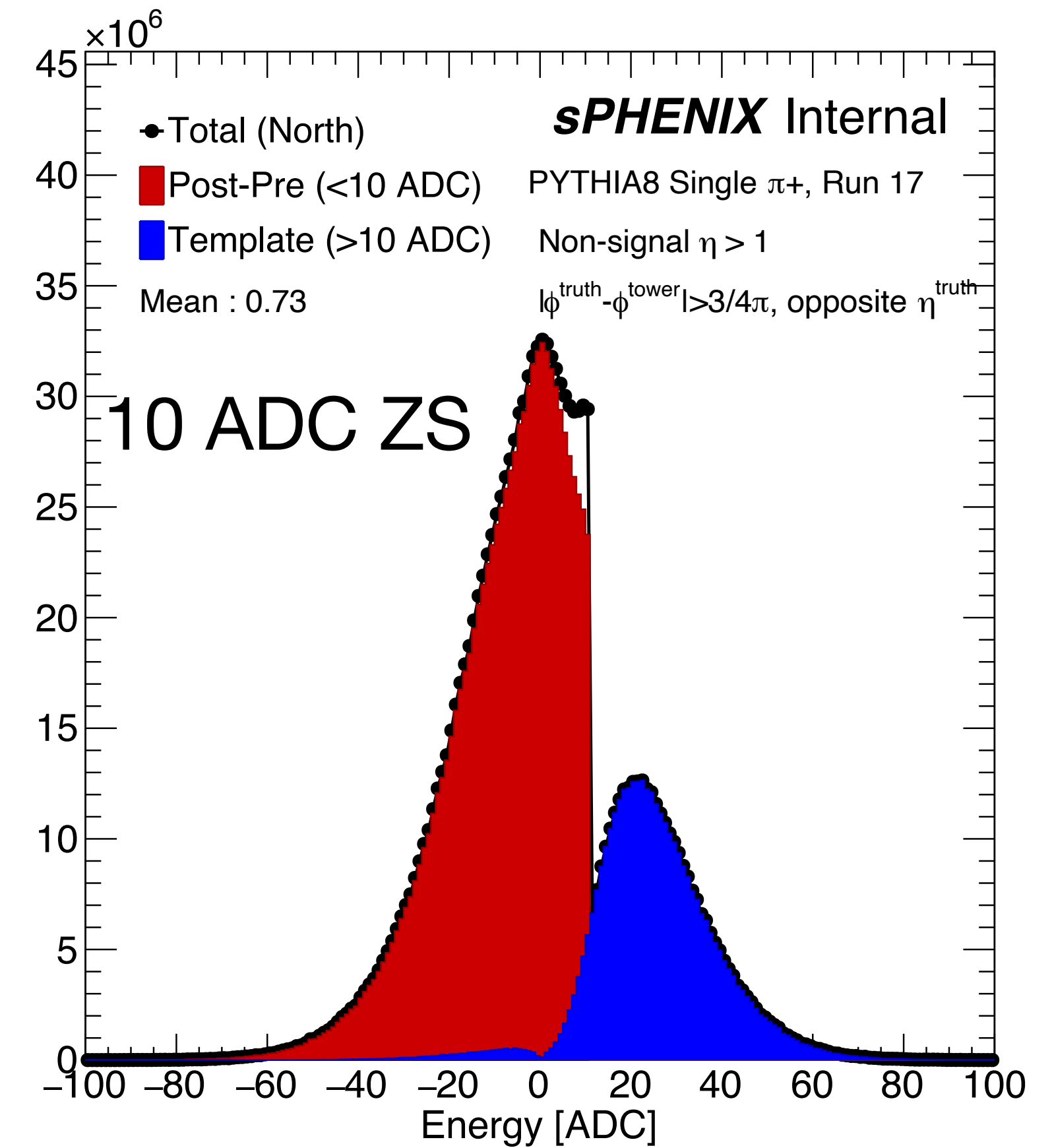
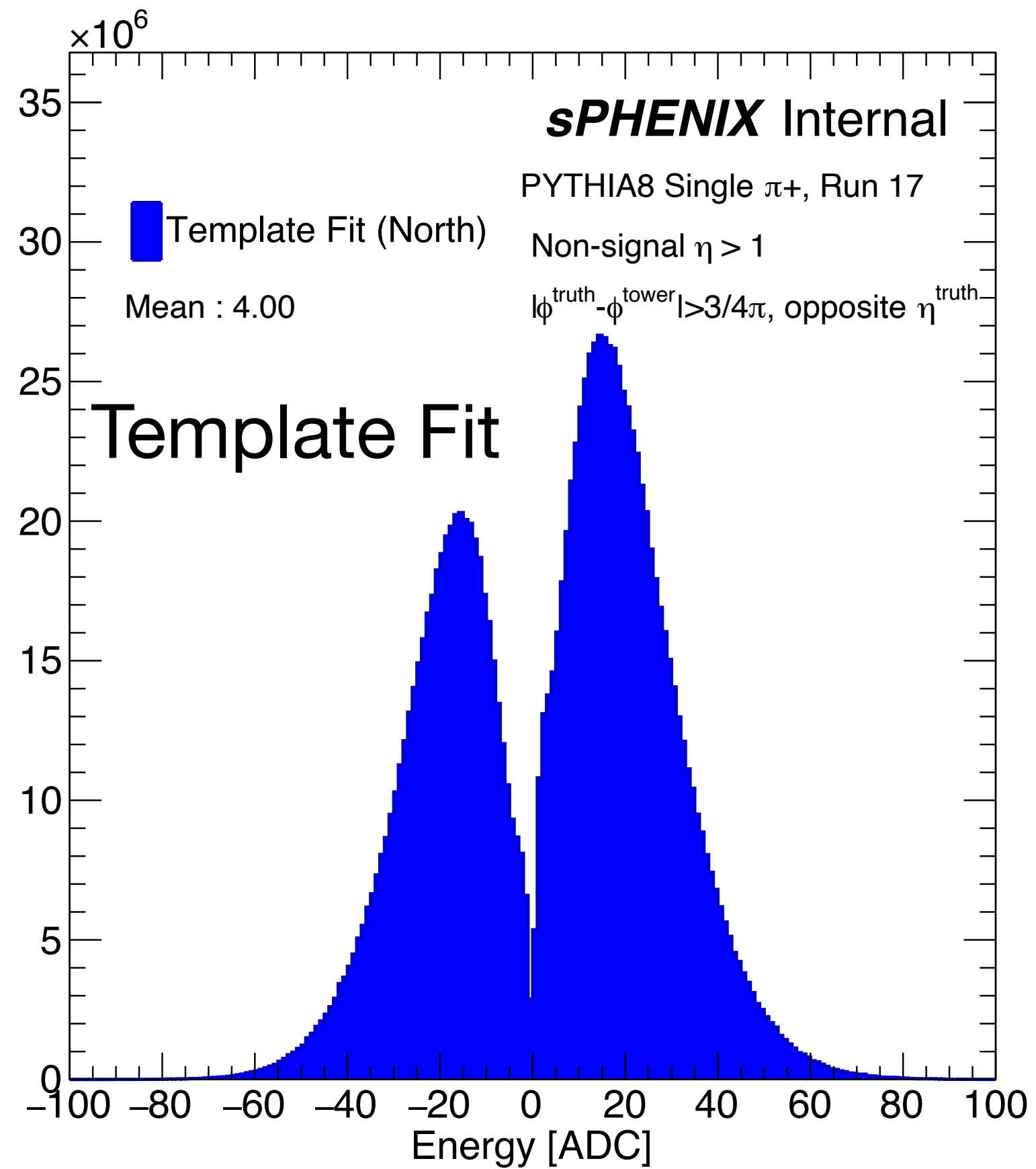
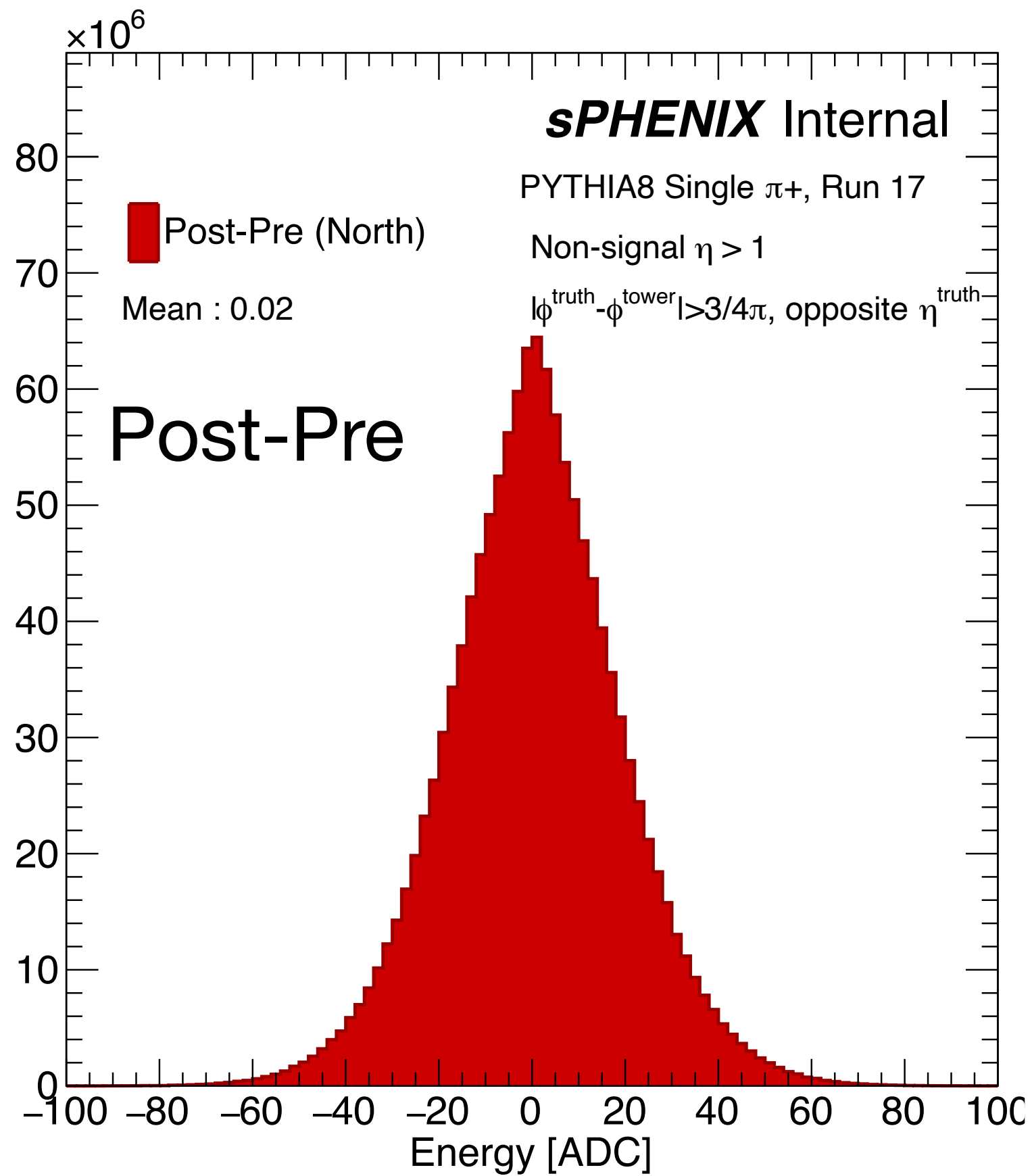




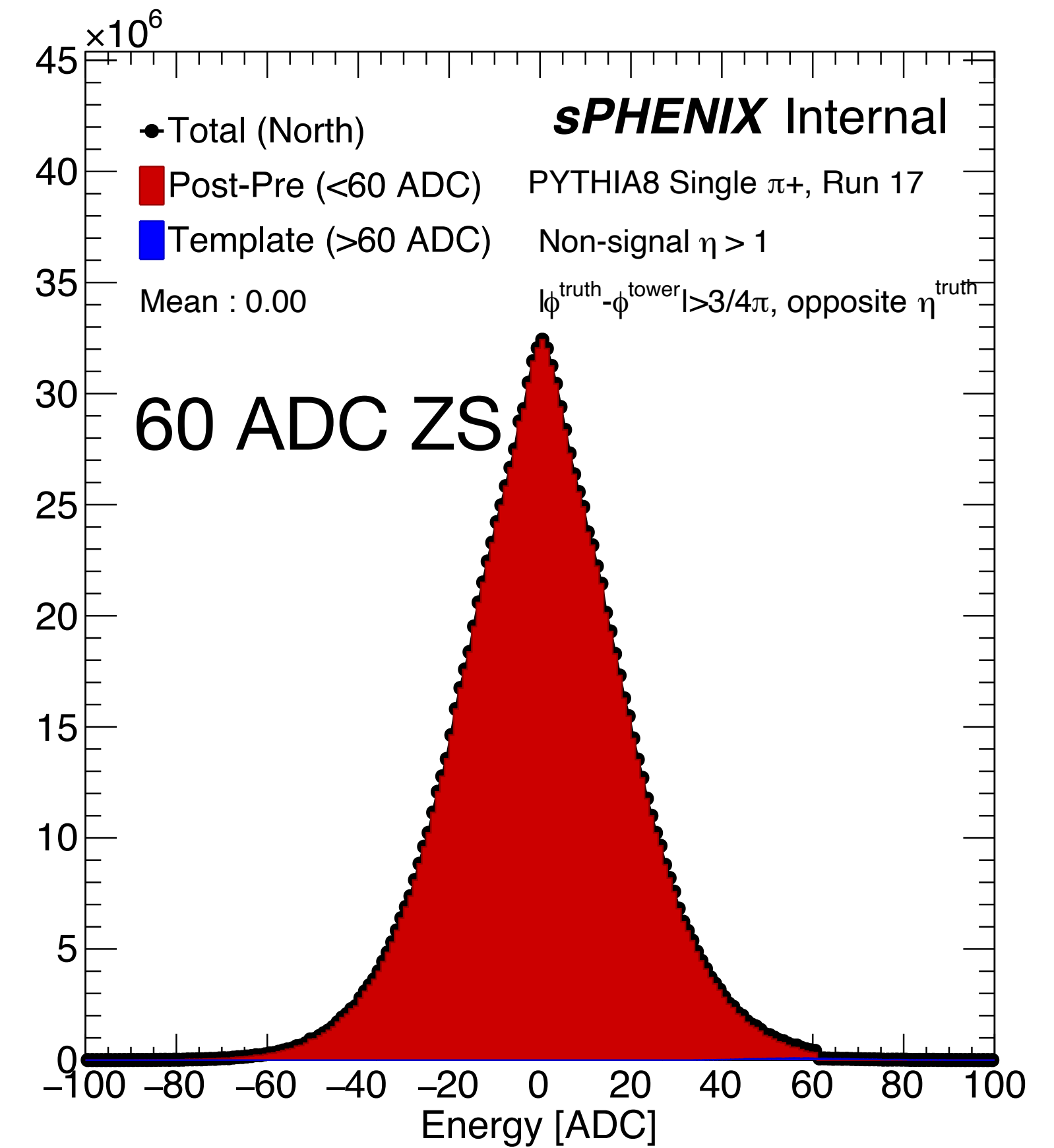
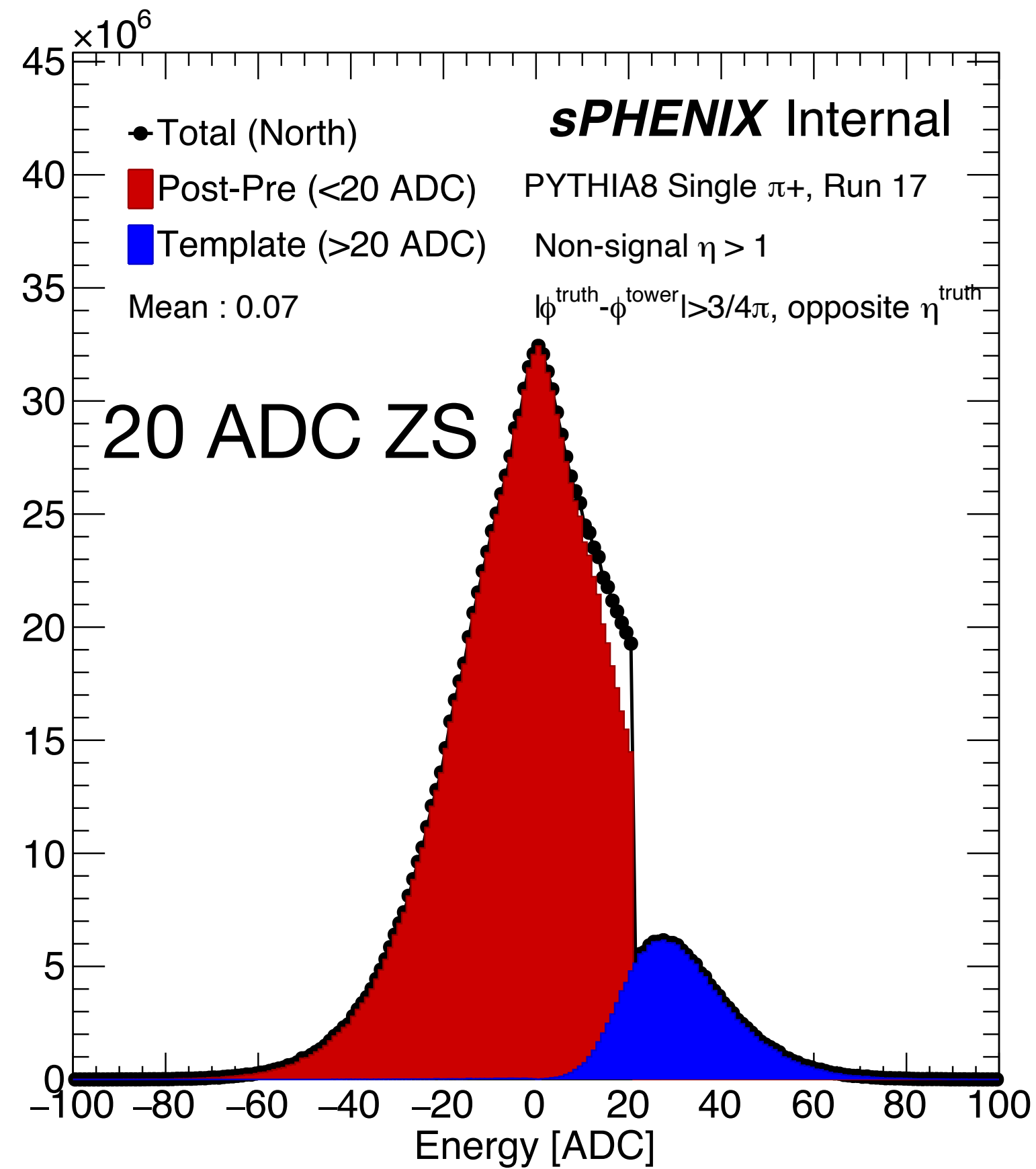
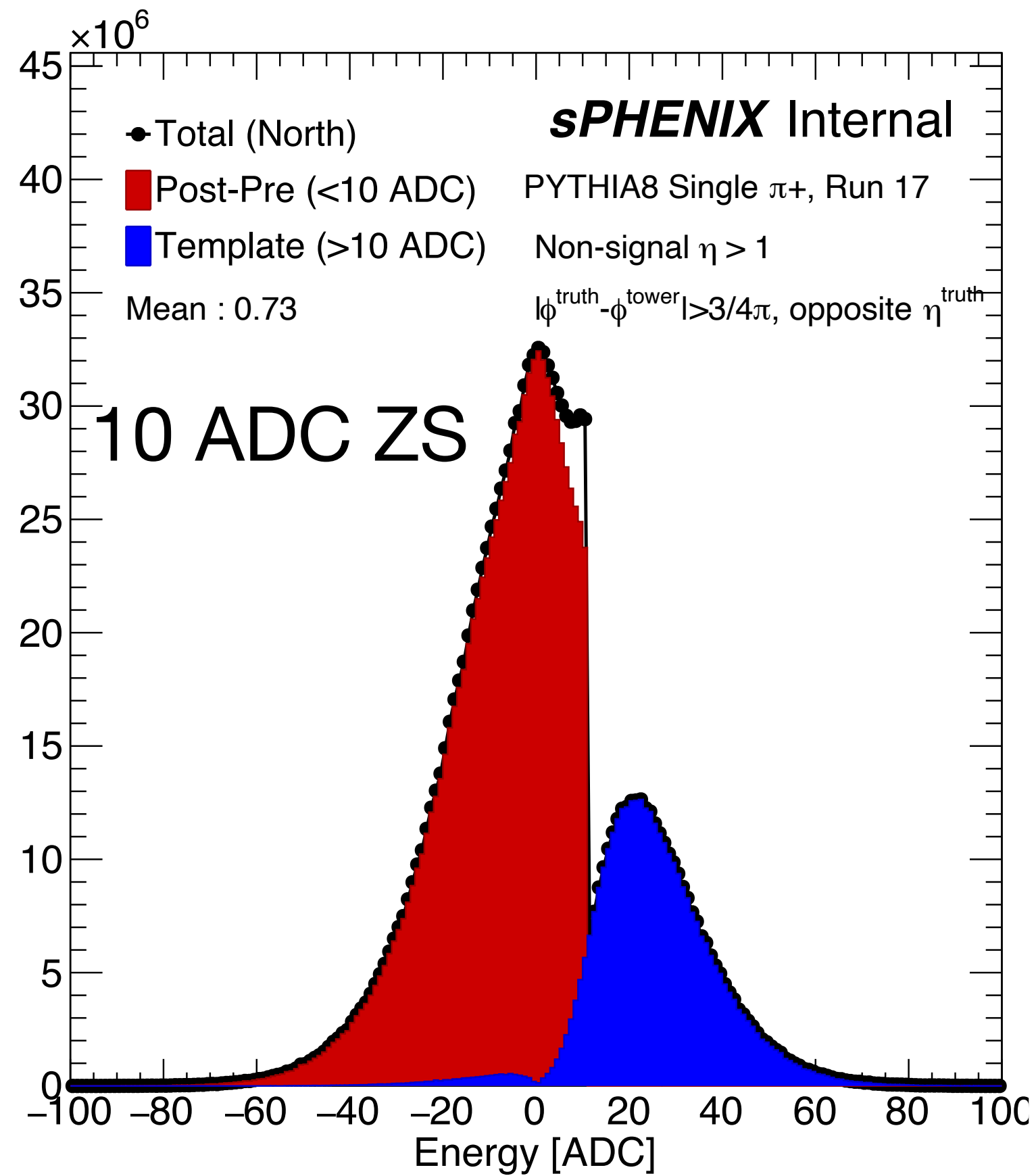
Selected towers : ensure no signal contribution

Example of ~20 ADC 1 sigma ped. fluctuation for emcal

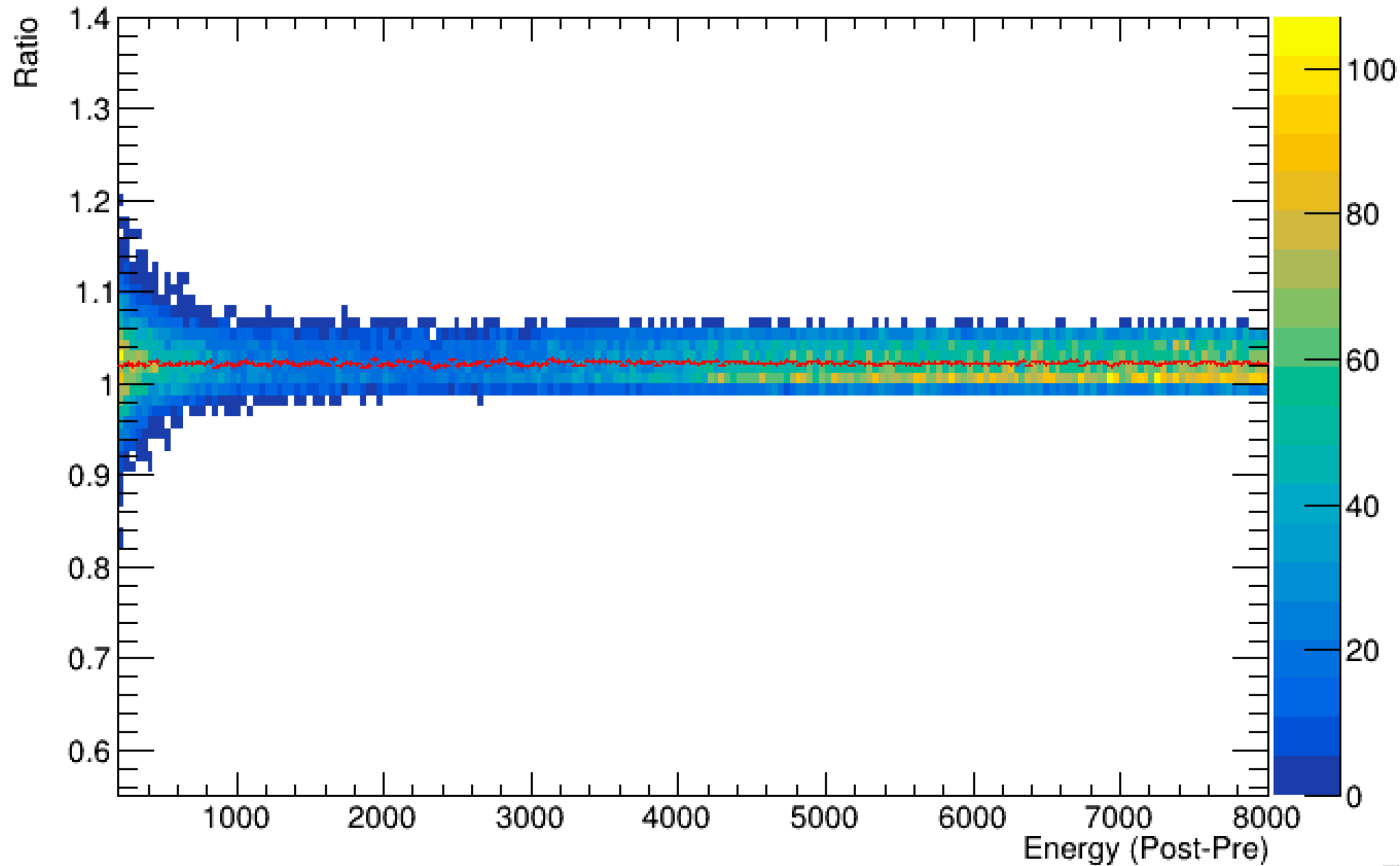




- Positive bias for template fit (known)
- 10 ADC software ZS level — example of too low th. —> Smearing effect causes bump structure near threshold



- Getting similar mean for pure Post-Pre only in ~60 ADC ZS threshold
- Need to put a high enough software ZS level to ensure no bias on the pedestal from the template fit



- Template/Post-Pre response vs energy
- ~5% difference in the EMCal north side  
—> Similar to data above 60 ADC
- Uniform across input energy

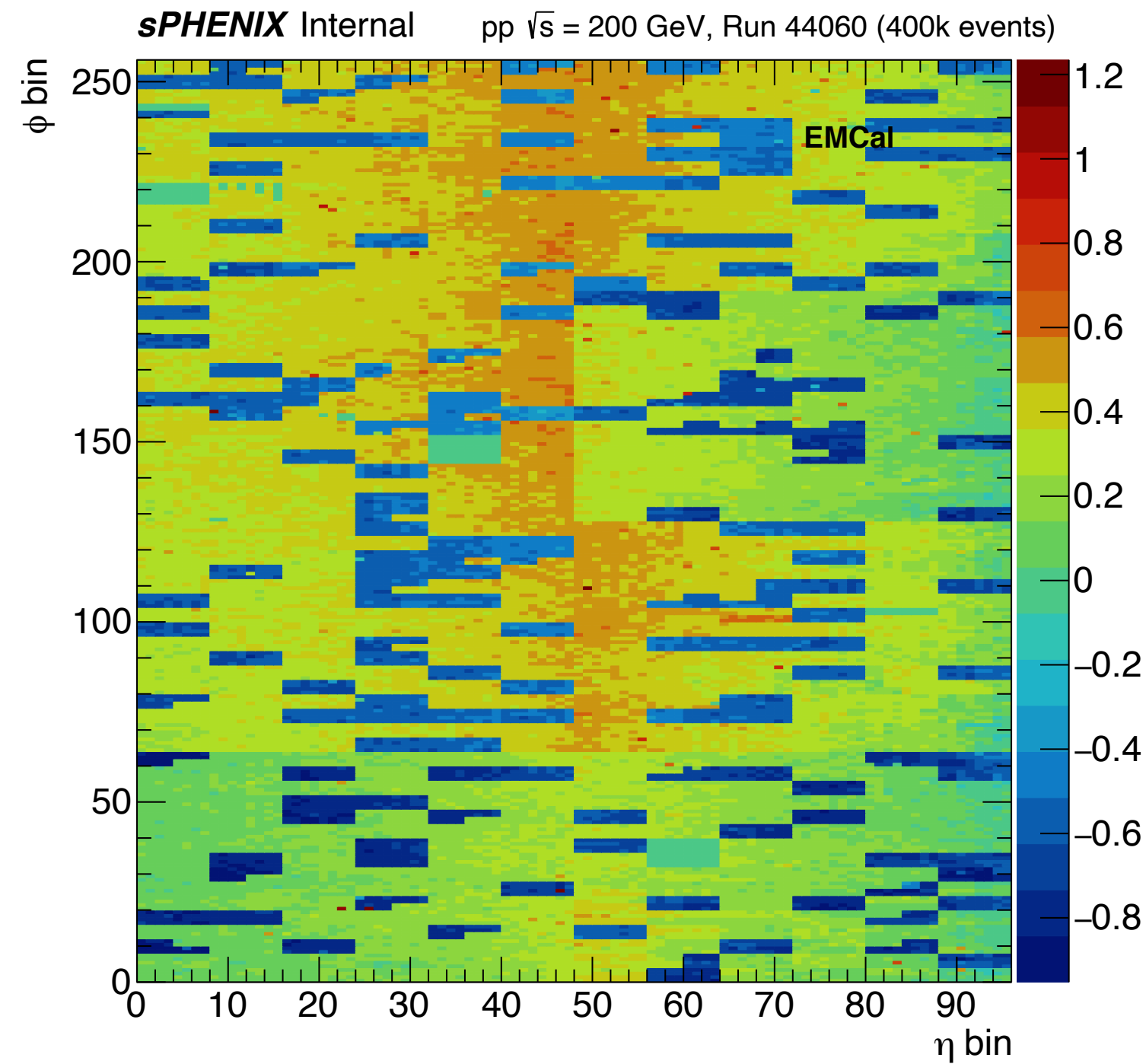
- Tower isGood :  $!(\text{noCalib} + \text{isHot} + \text{badChi2})$ 
  - Jet tower input : removing towers for isHot or badChi2 or noCalib or isNotInstr
  - EMCal cluster : removing towers for !isGood or badTime
  - Topo cluster : removing towers for !isGood
  - Cluster Isolation : removing towers for isHot or badChi2 or isNotInstr or badTime

Perhaps a good time to converge for a single usage of a “good” tower status?

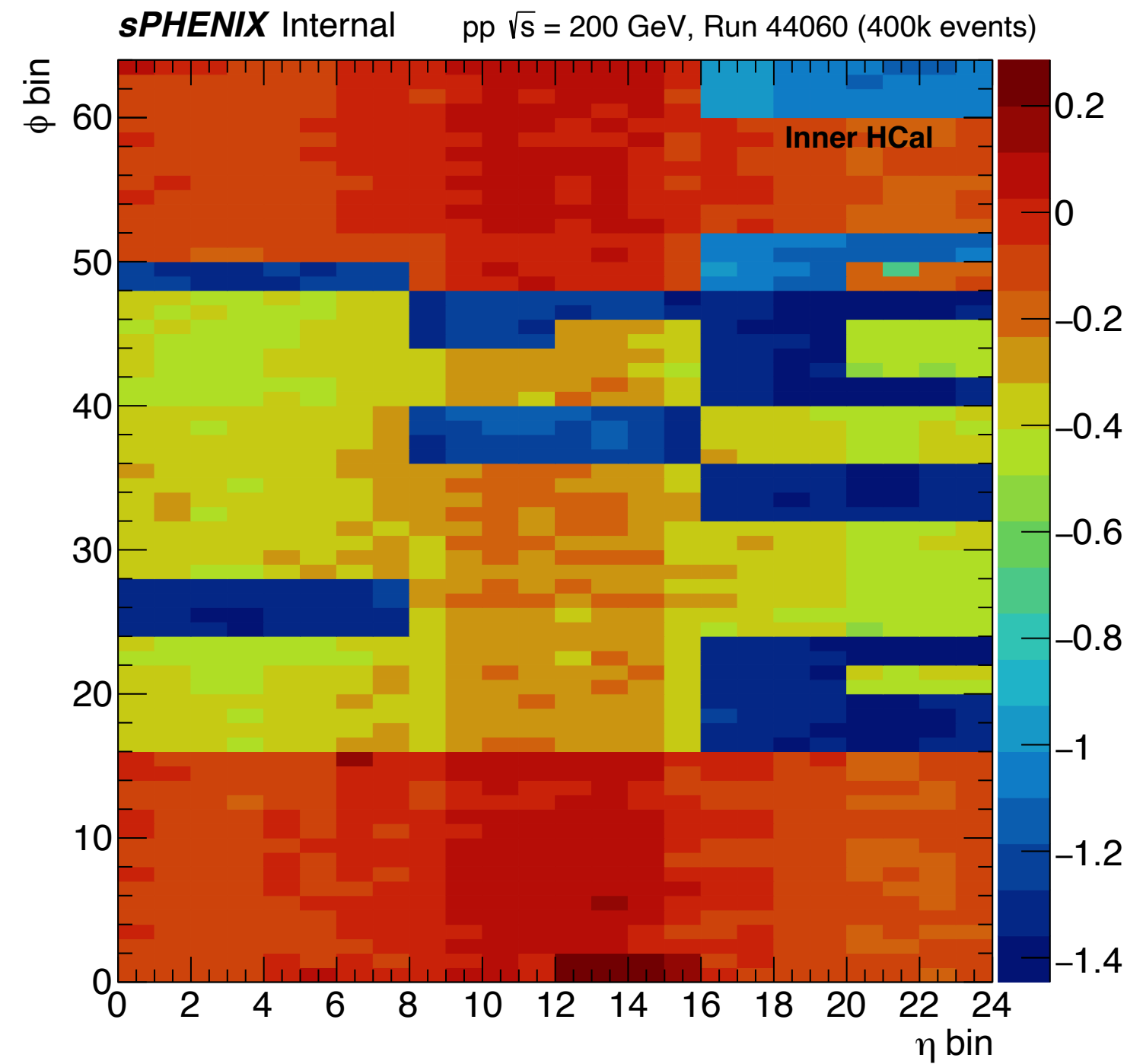
- Need to put high enough software ZS to not be biased from the template fit
  - Tests ongoing for embedding same ch-by-ch ZS level based on hardware thresholds
  - The ‘high enough’ threshold should eliminate out of time contributions
    - or need to introduce timing cut
- Cross calibration corrections (template vs post-pre) for low-energies below software ZDC
- Finalize “isGood” function and apply it everywhere consistently

# Back-up

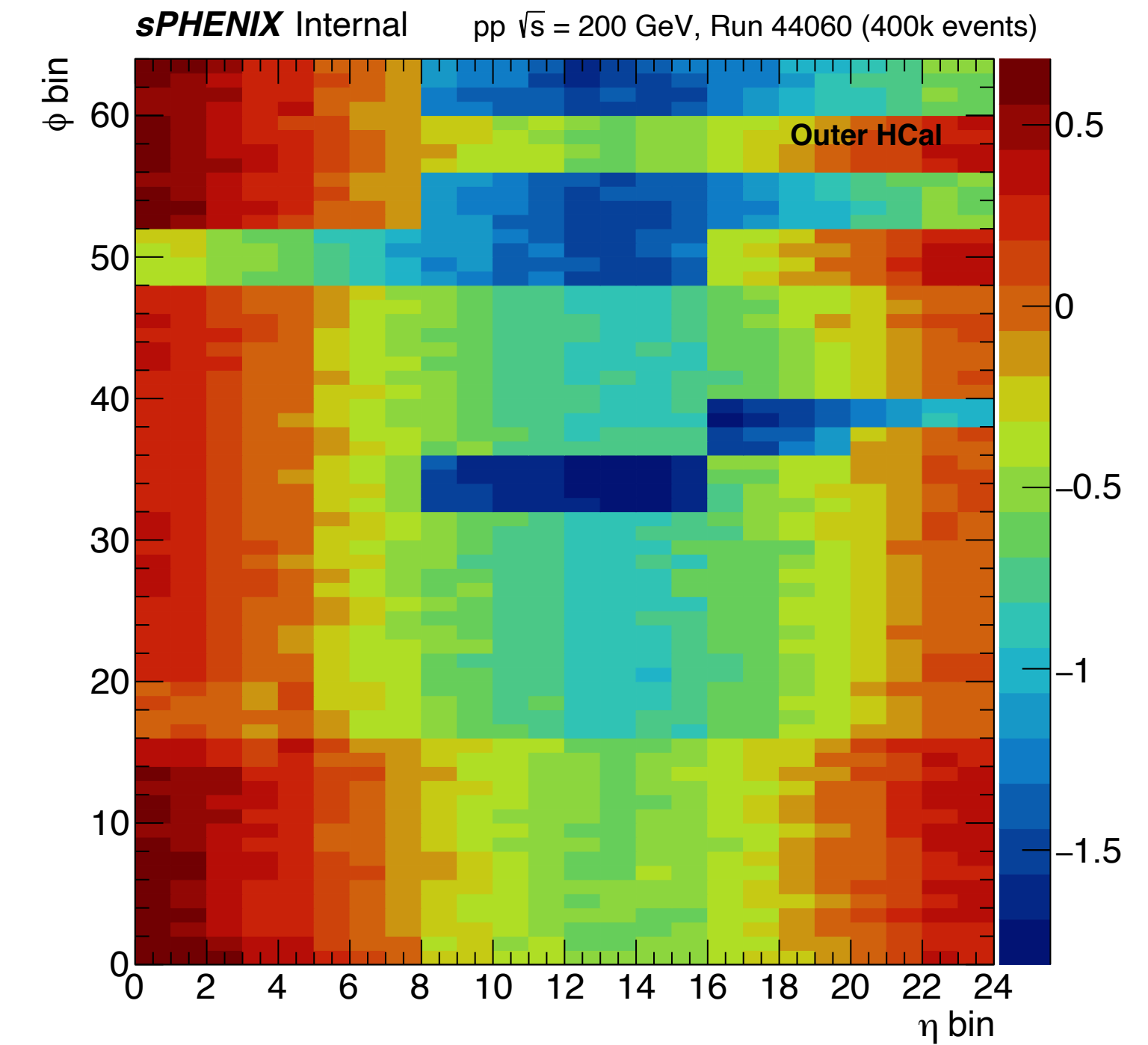
## EMCal



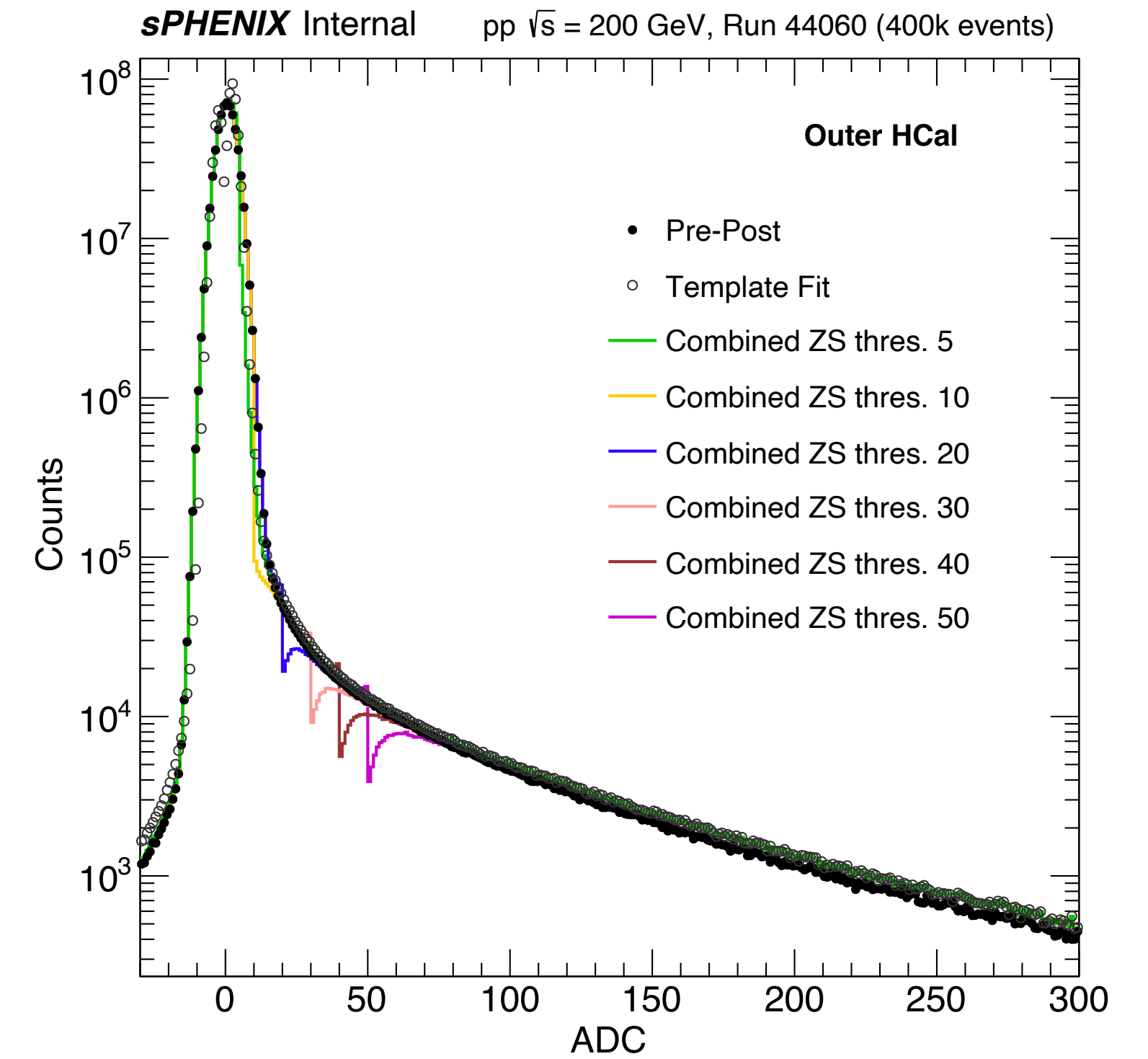
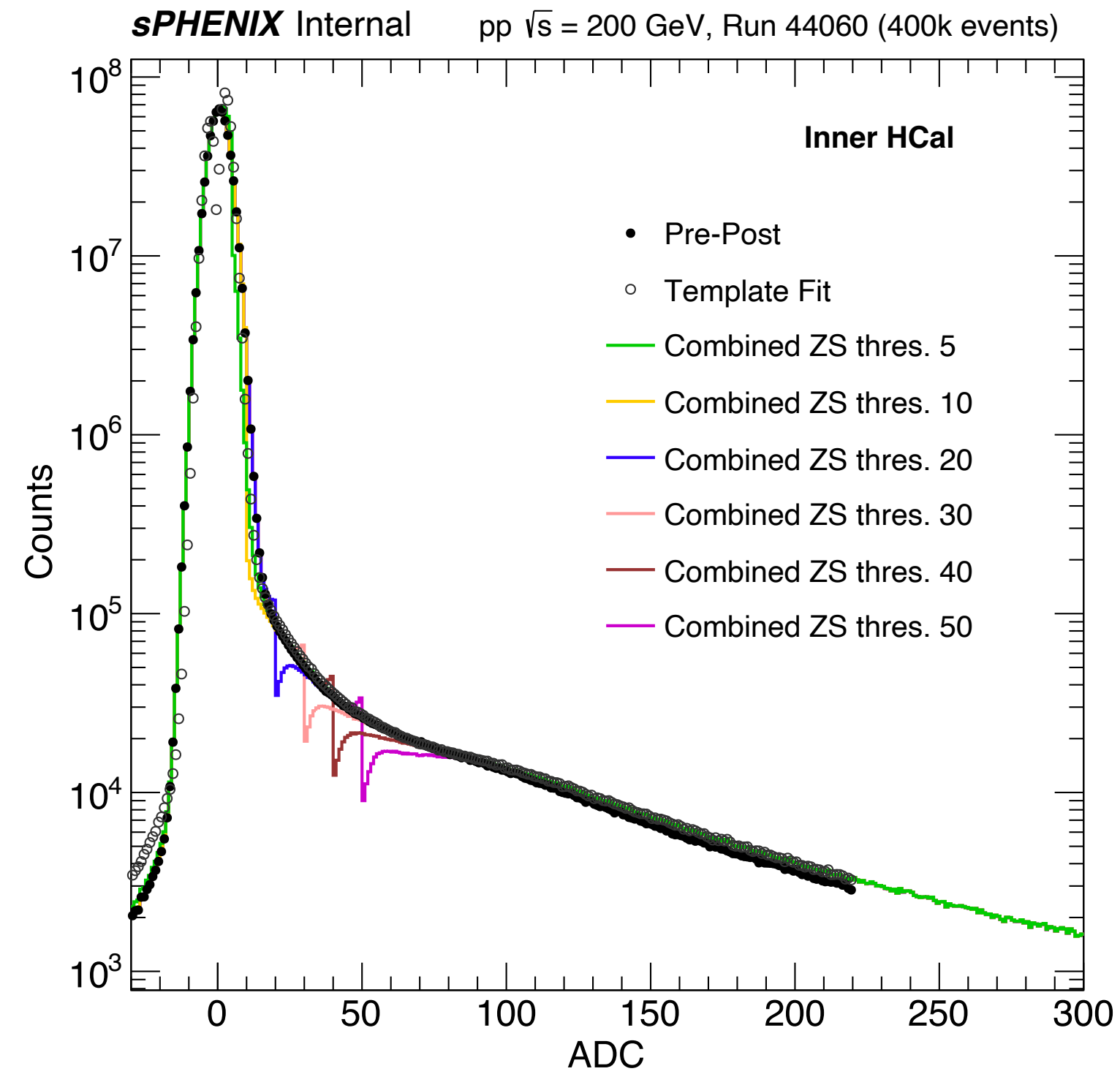
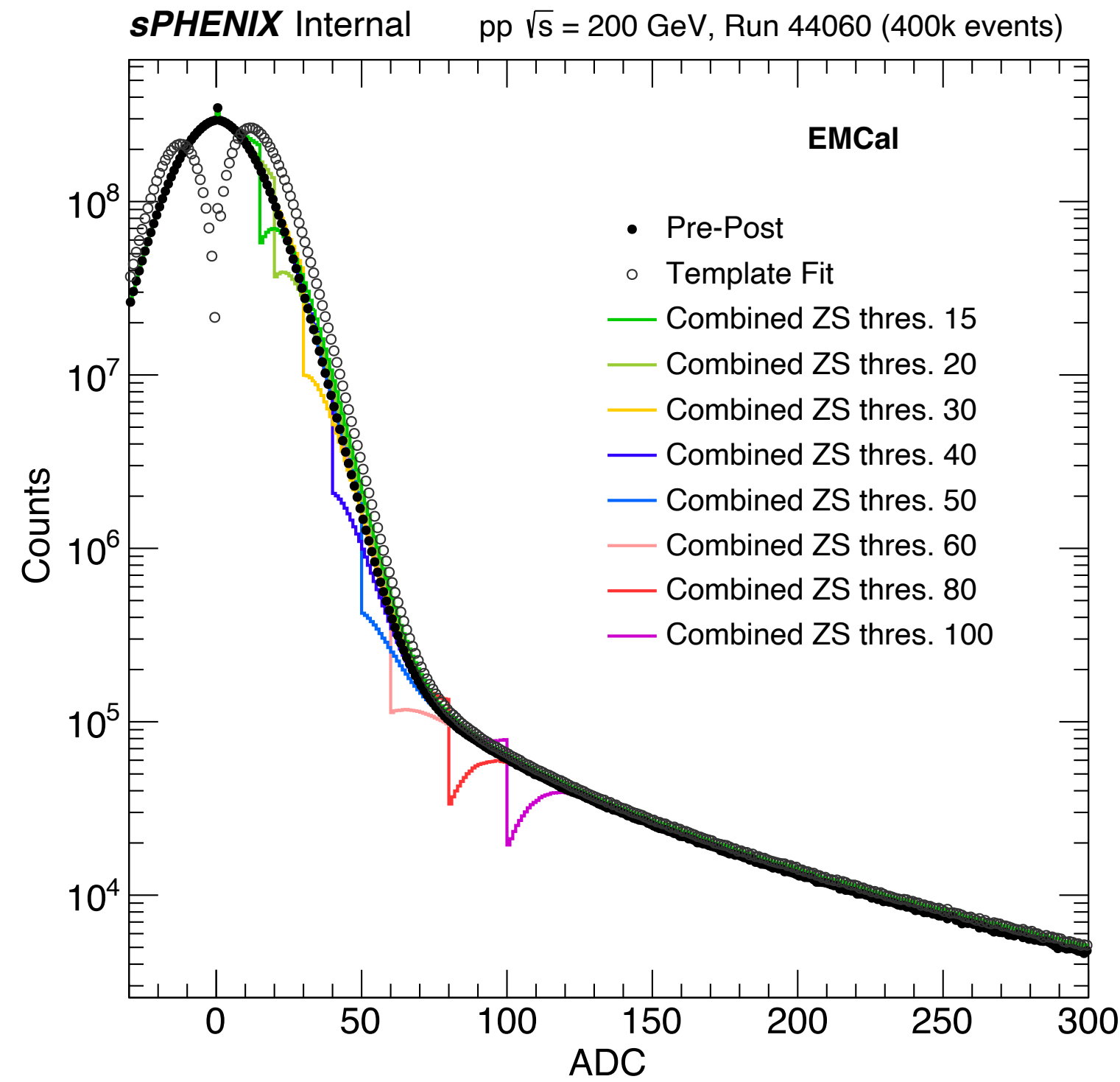
## Inner HCal



## Outer HCal

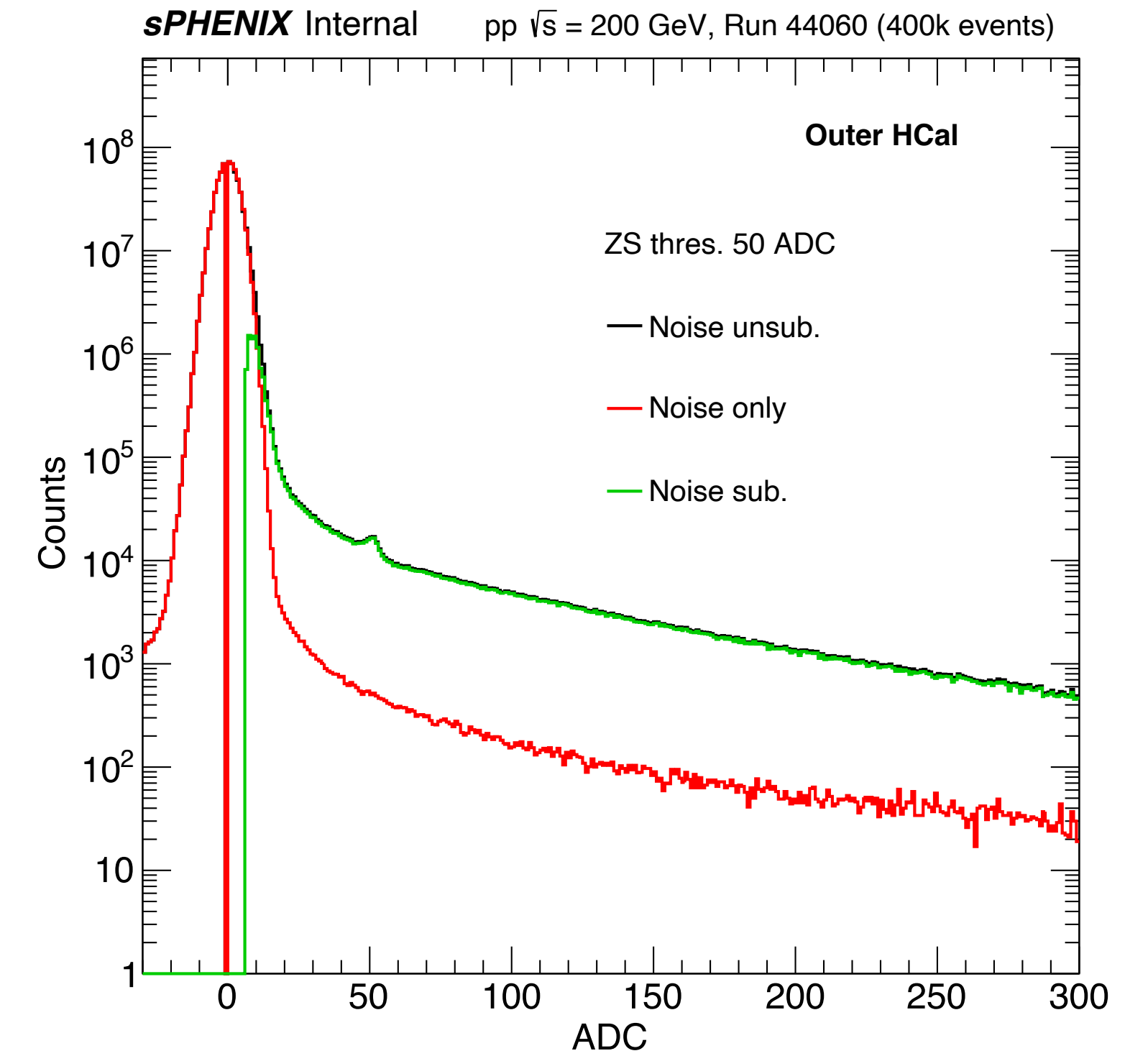
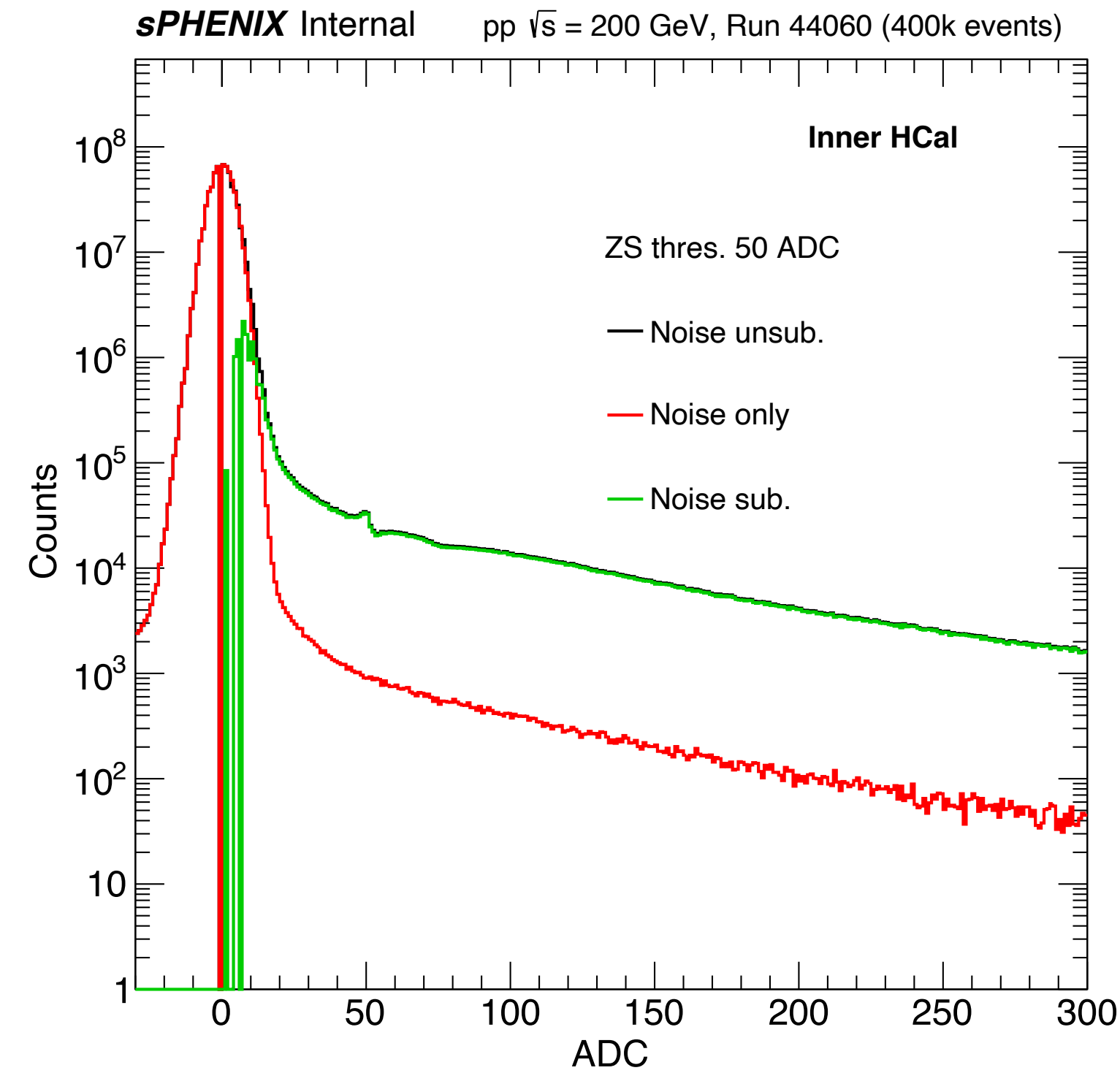
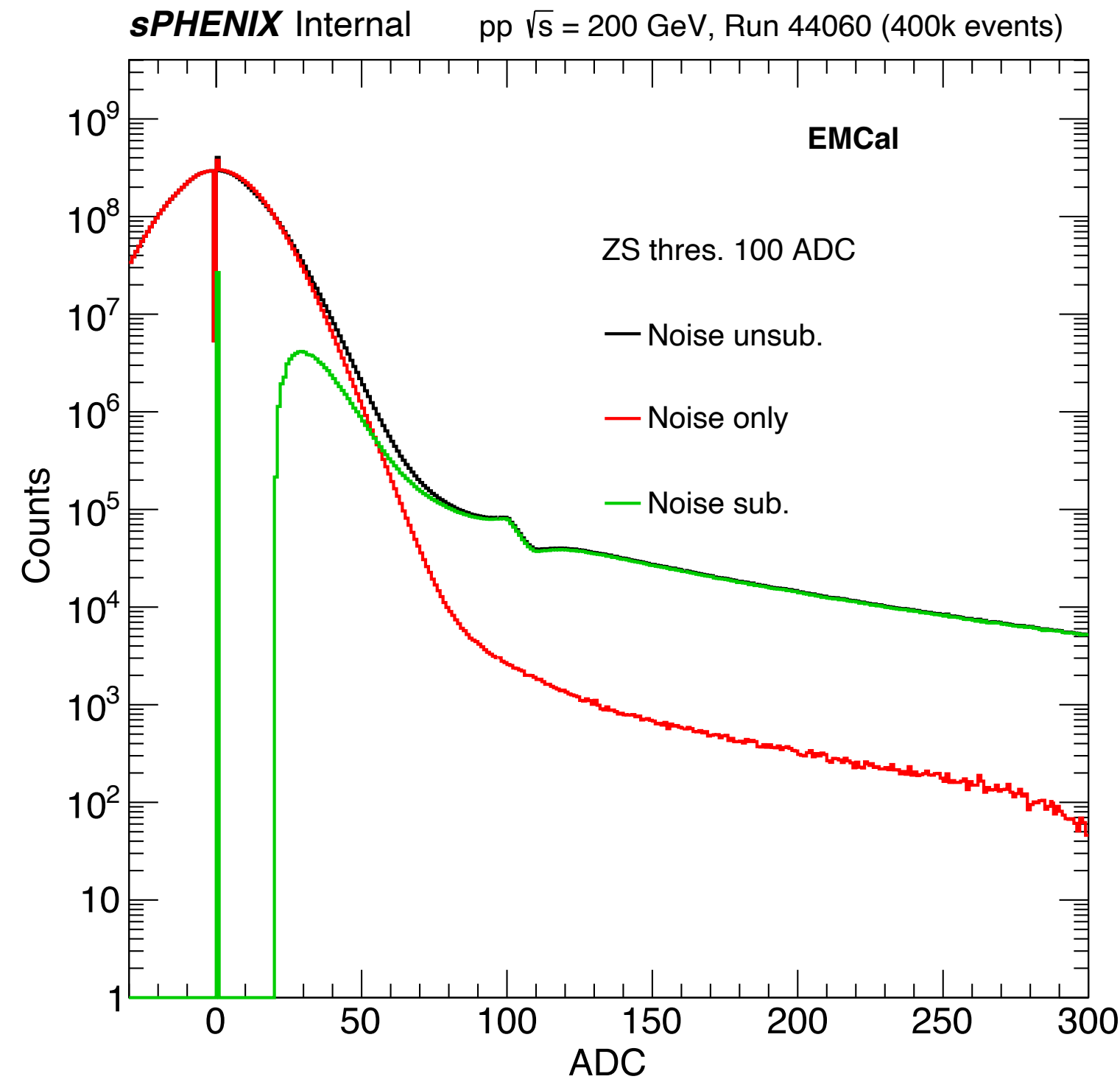


- Template Fit peak position for ADC > 60

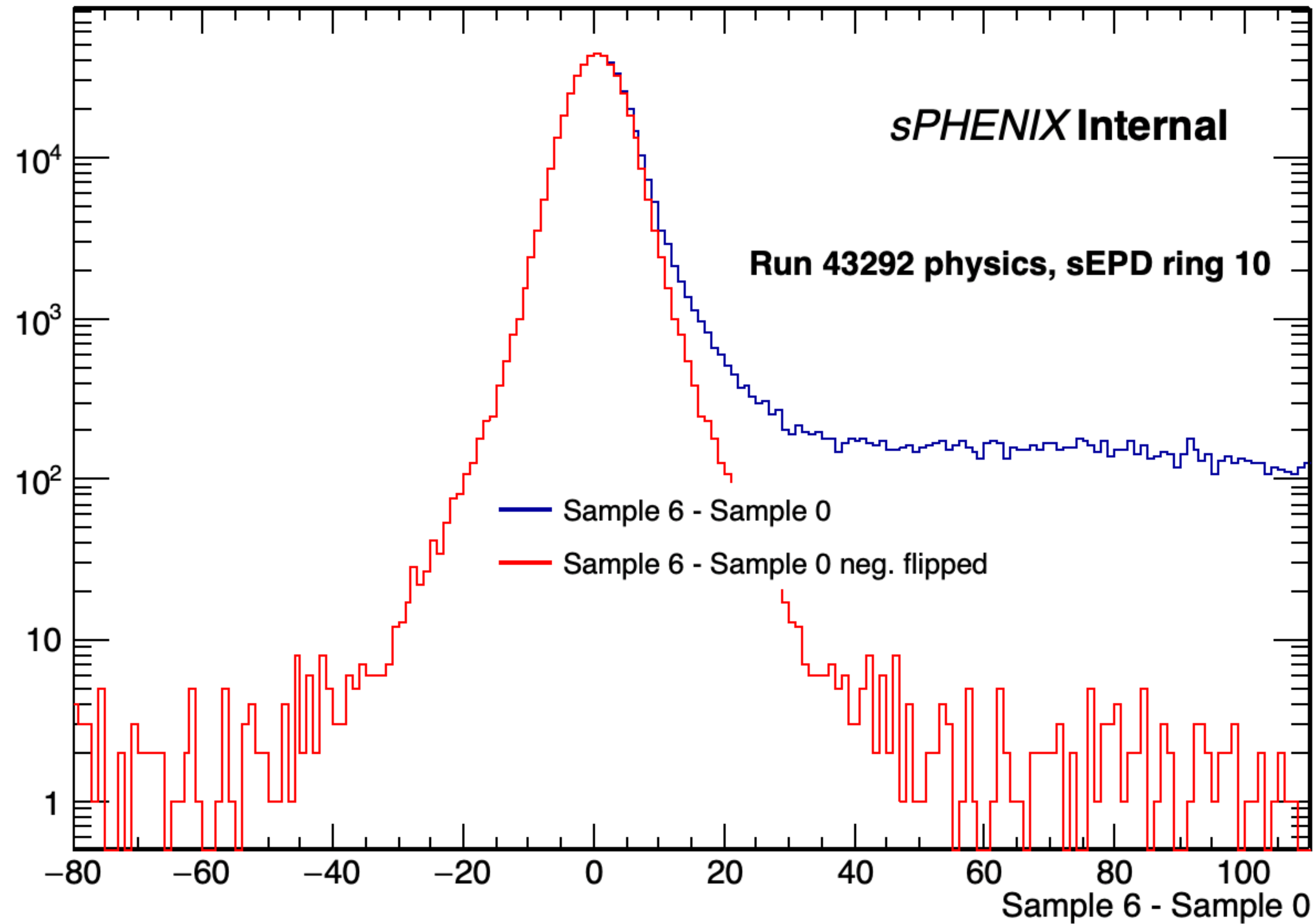


- Combined ADC distribution
  - If Post-Pre > Threshold → Template fit
  - else if Post-Pre ≤ Threshold → Post-Pre
- Need to study with higher energy data or simulation for calibration of Post-Pre





- Noise derived from the negative side of the Post-Pre ADC distribution
- Bump structure near the threshold to switch to template fit

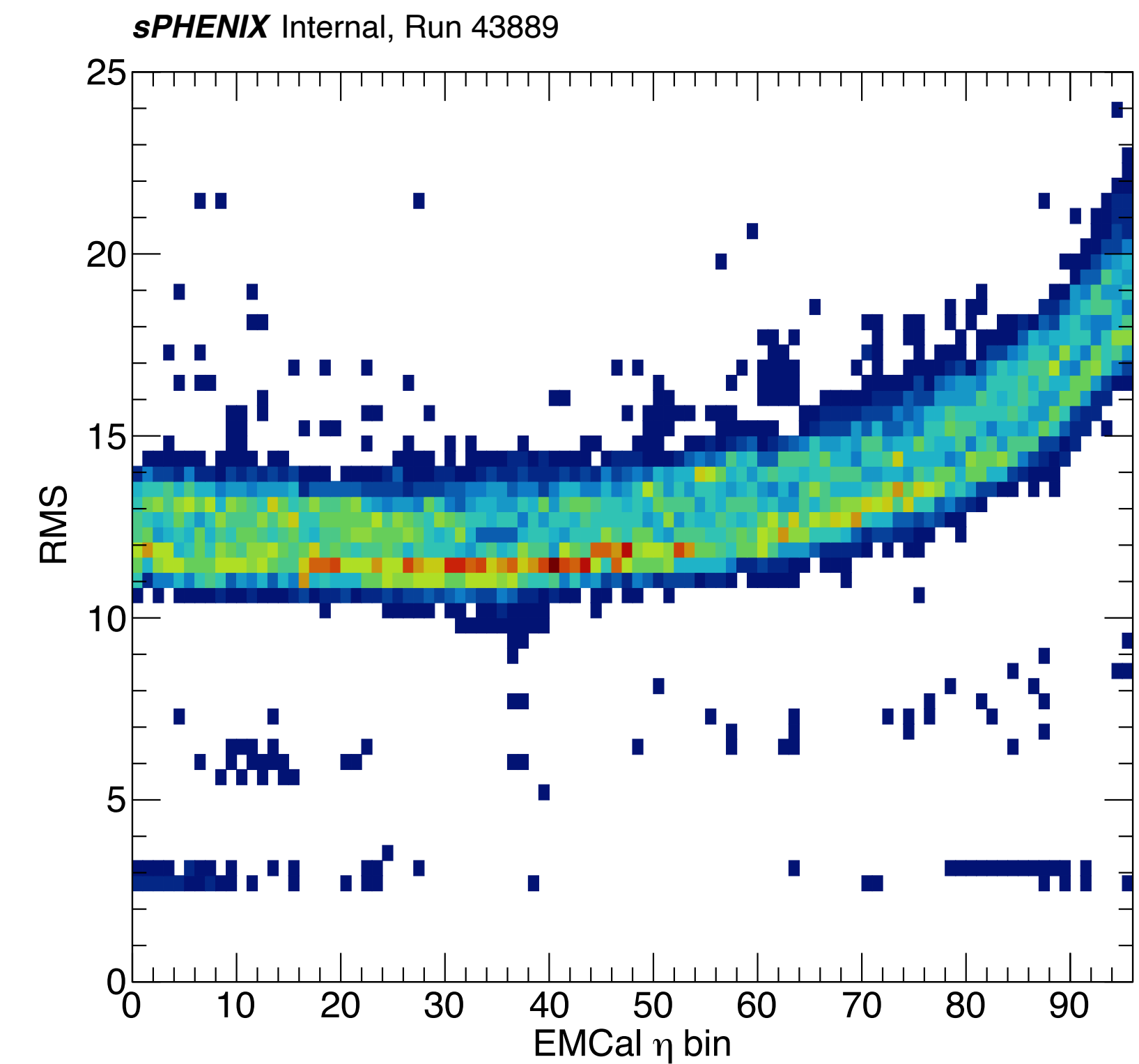
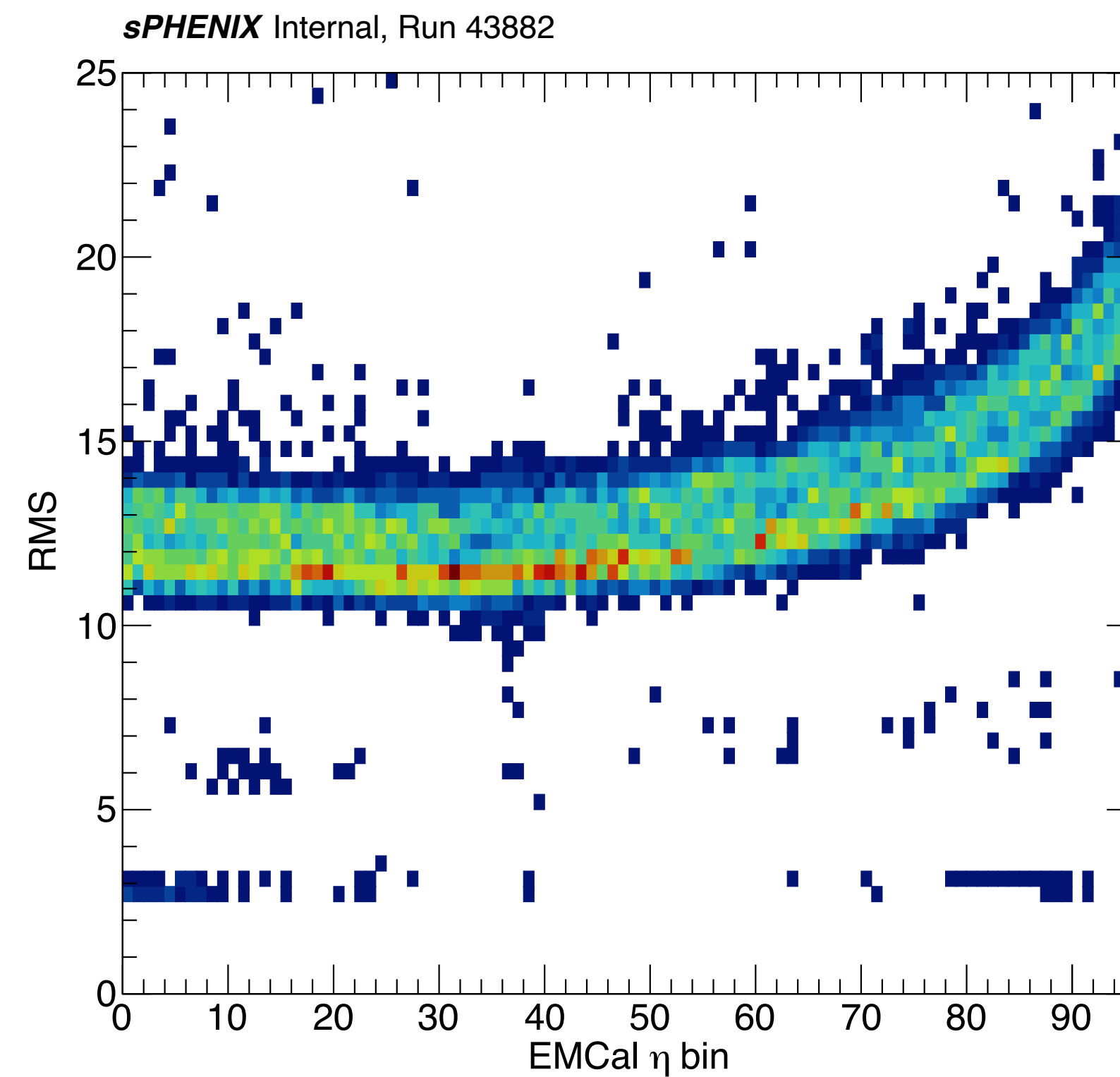
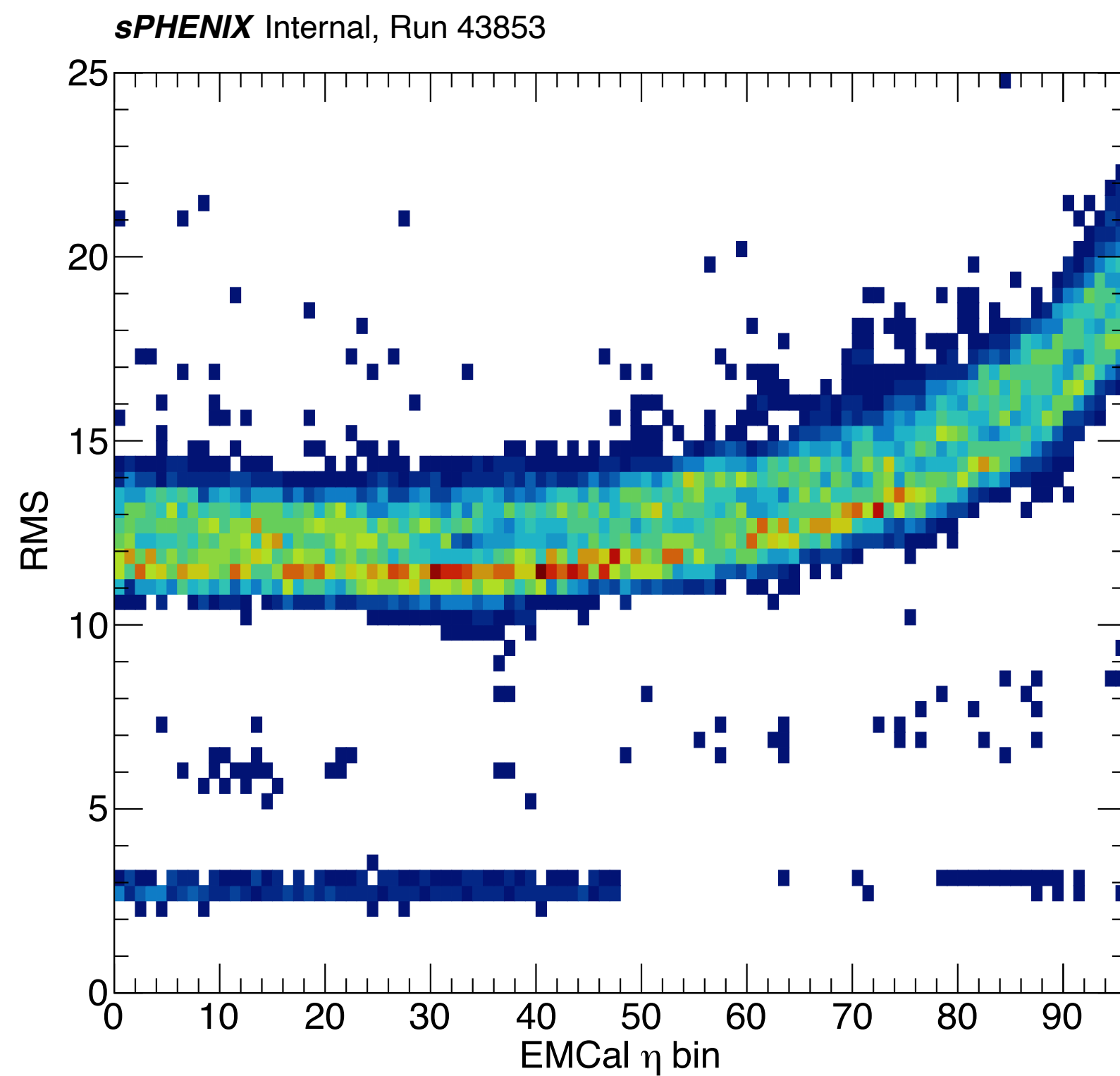


- Idea to take negative side of “pre” and “post” to derive the noise level
- Ch-by-ch noise calculation and take RMS as ZS threshold
- Even with ZS, “pre” and “post” information are stored in the data stream

Run 43853 (beginning of store)

Run 43882 (after ~5-6 hours of store)

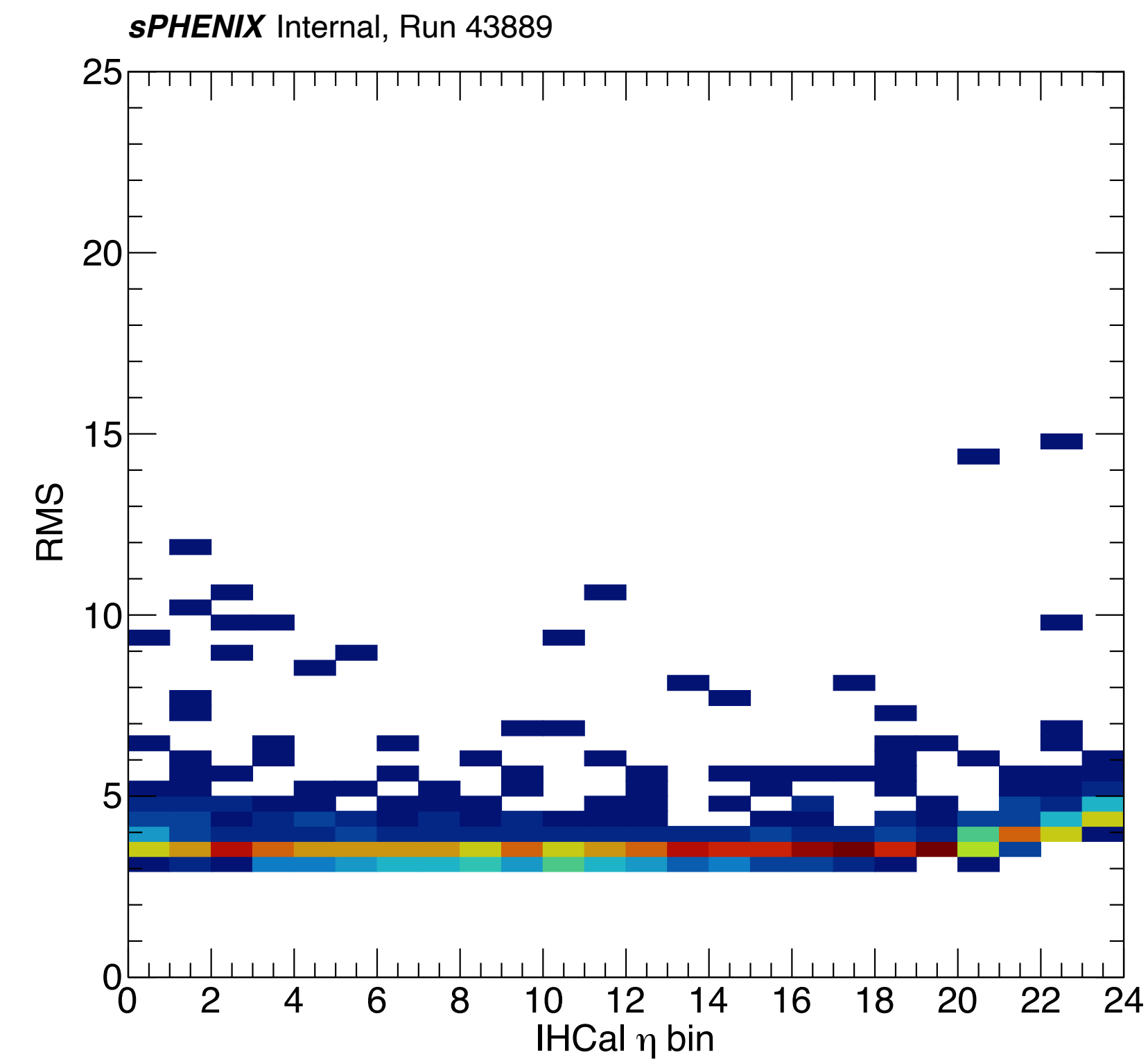
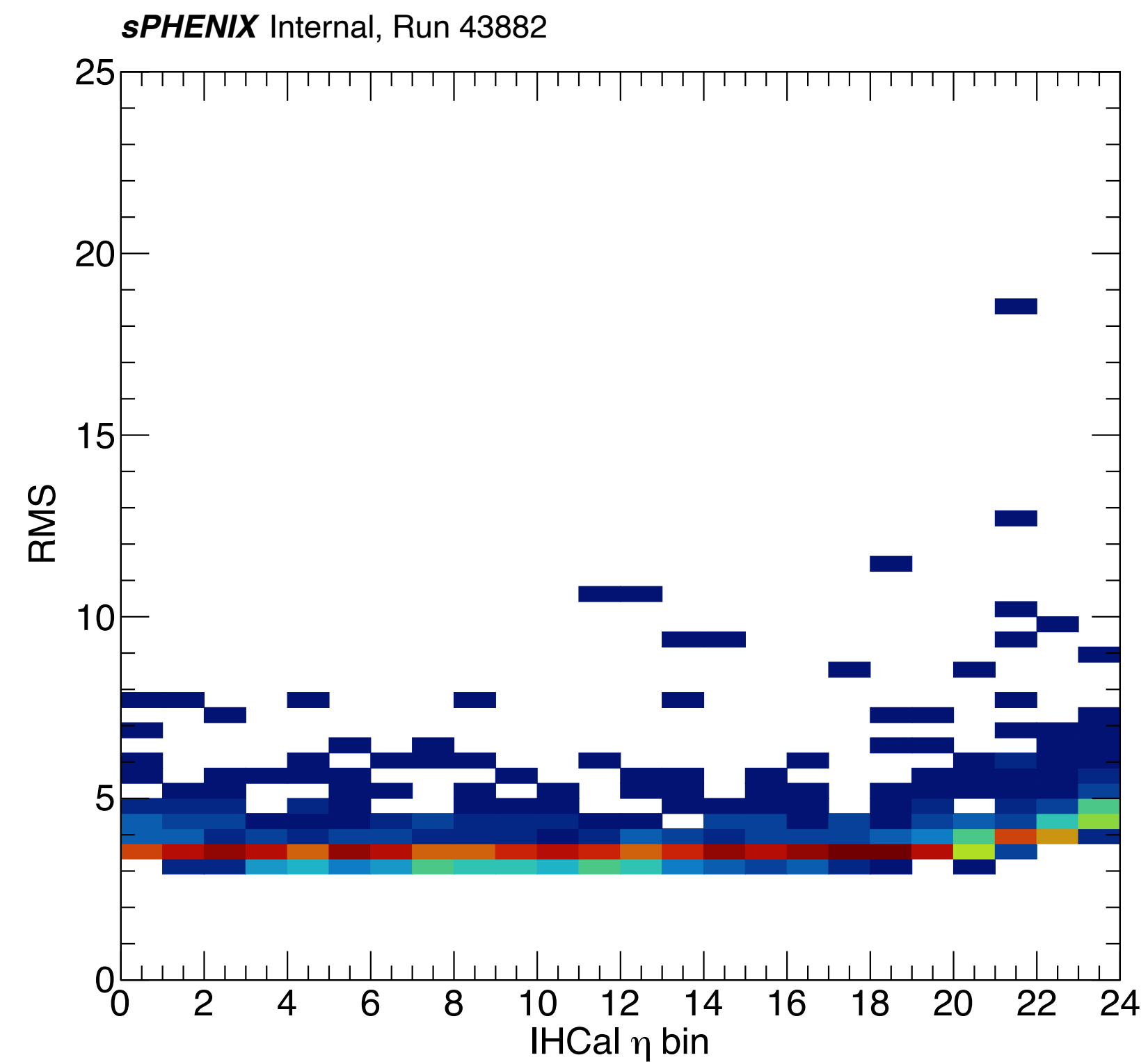
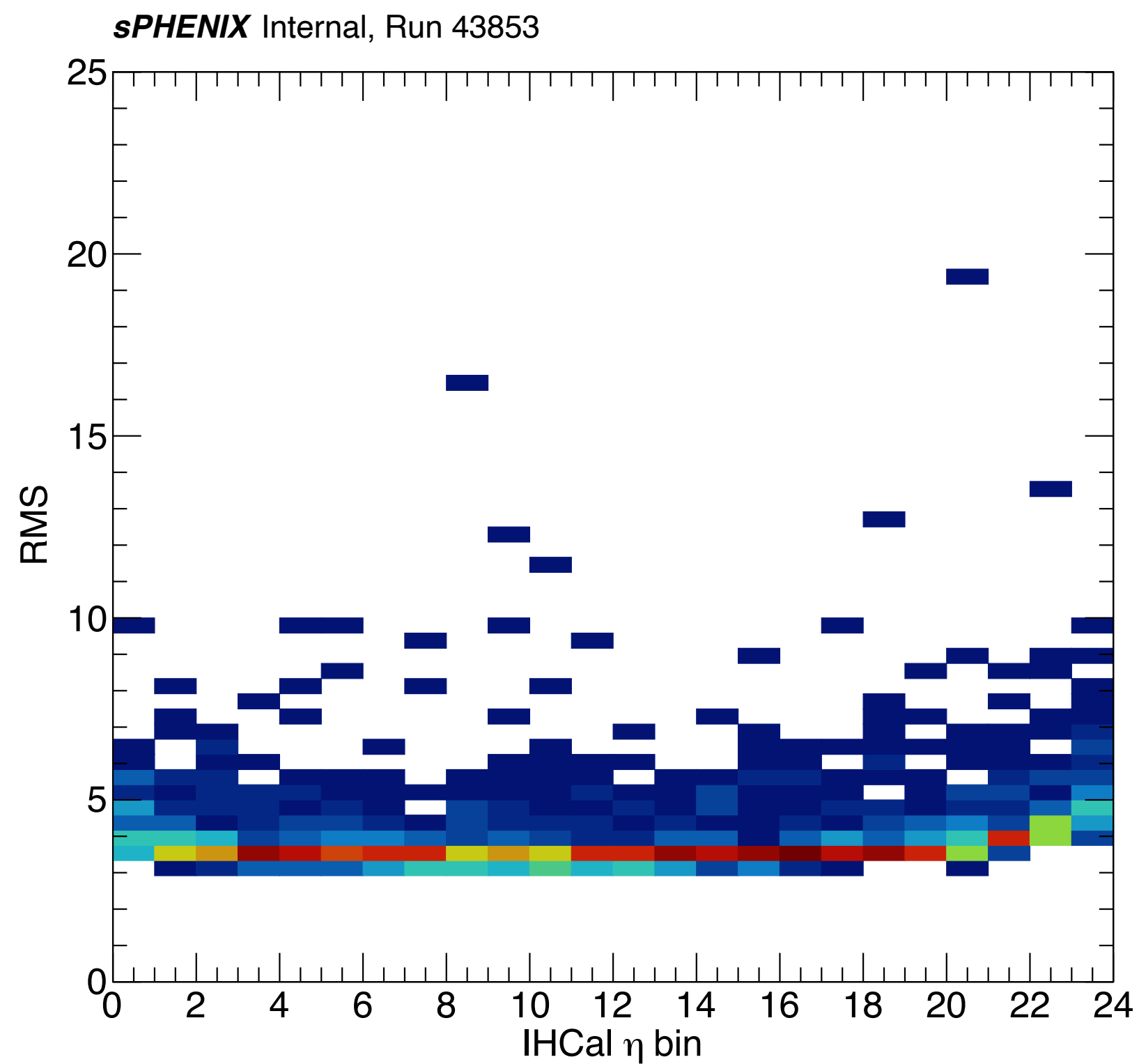
Run 43889 (end of store)



Run 43853 (beginning of store)

Run 43882 (after ~5-6 hours of store)

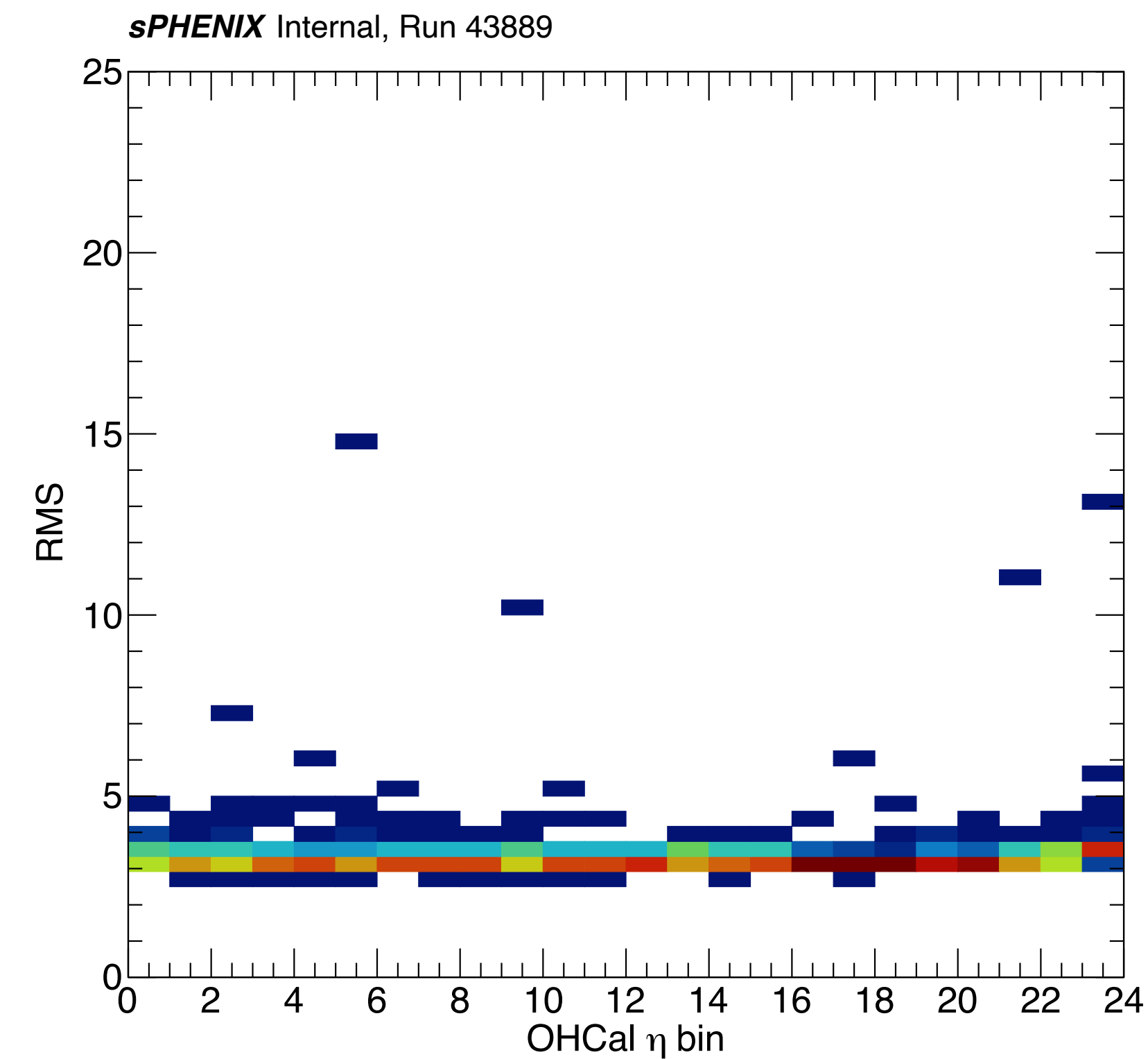
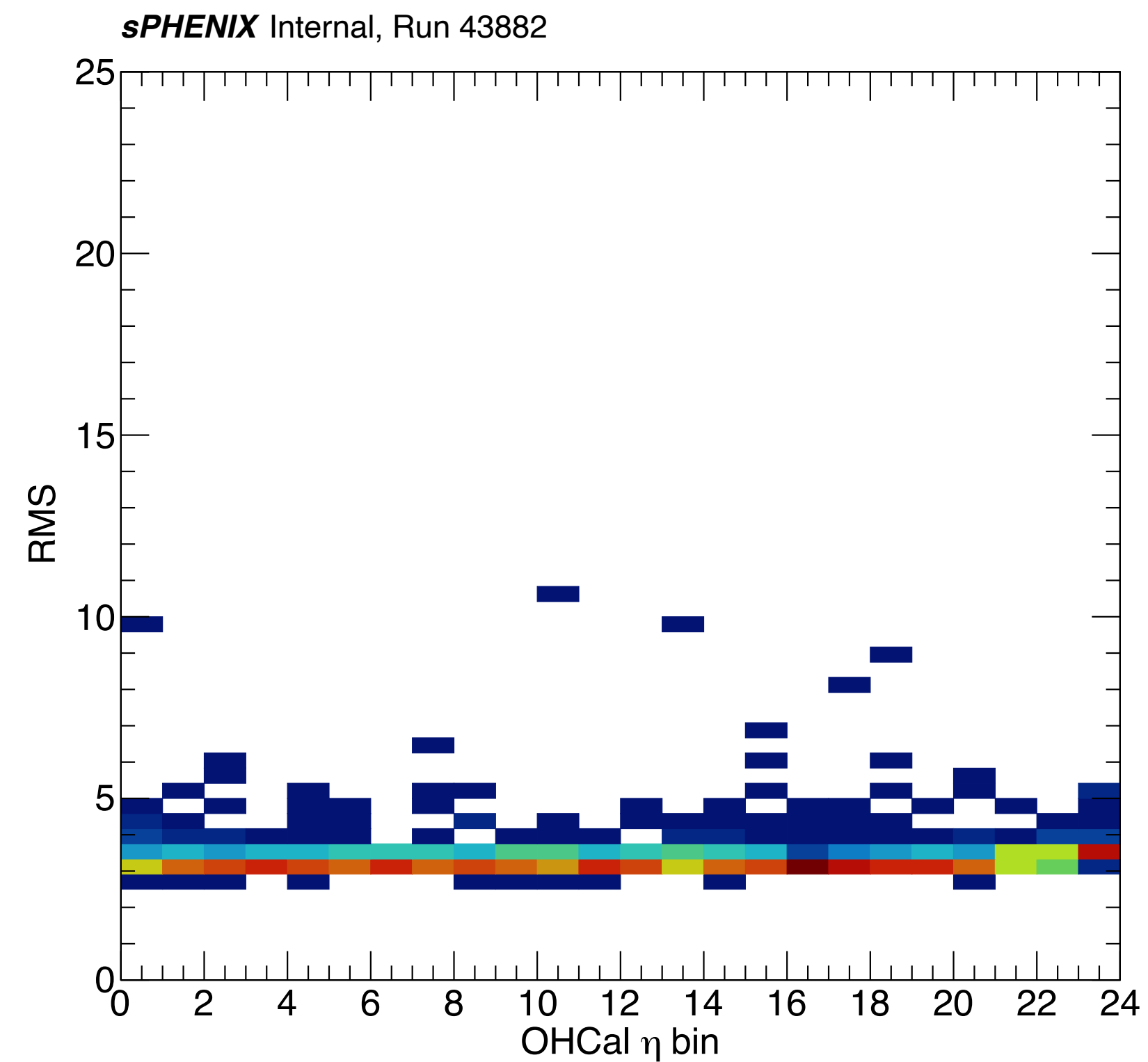
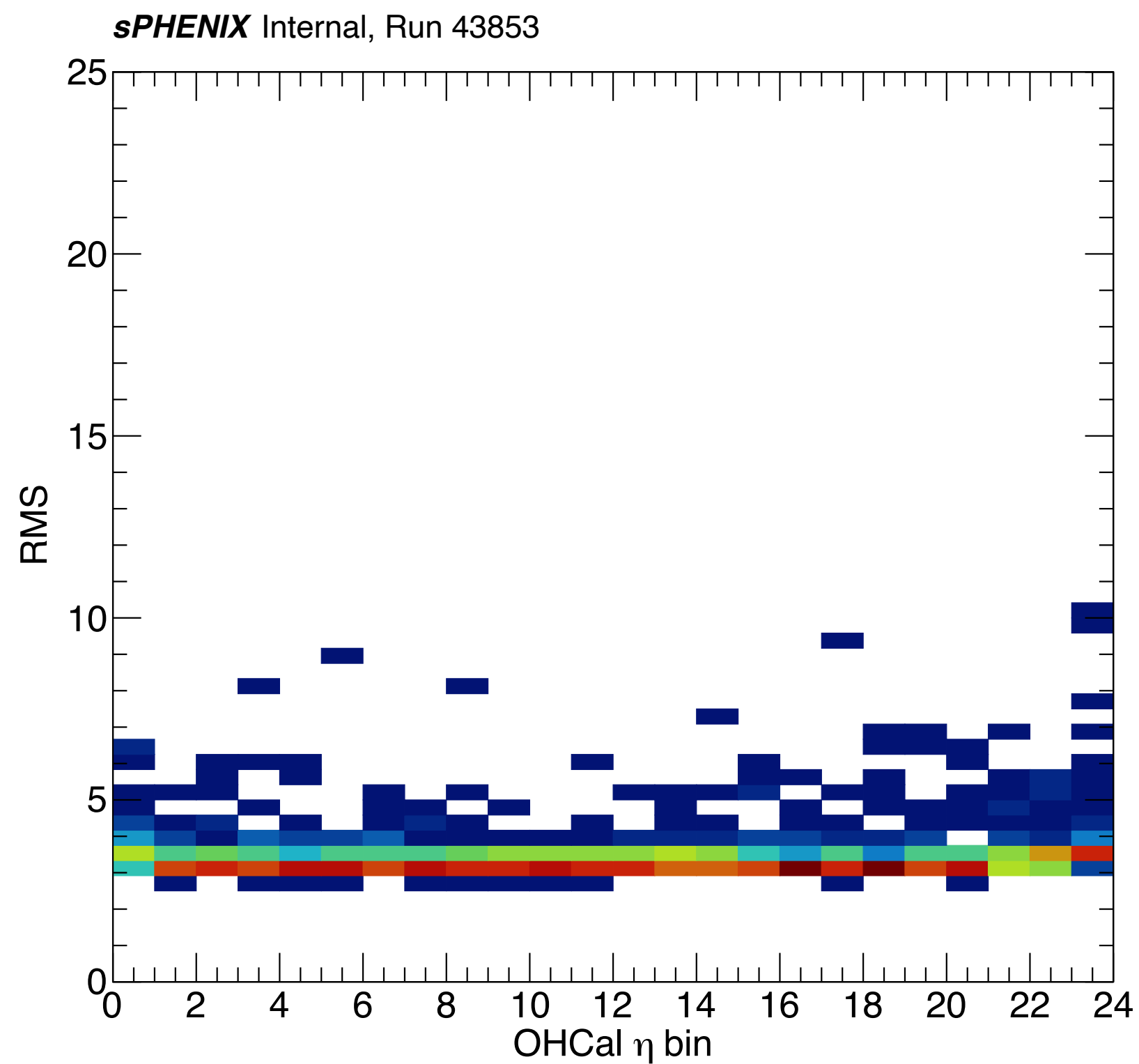
Run 43889 (end of store)



Run 43853 (beginning of store)

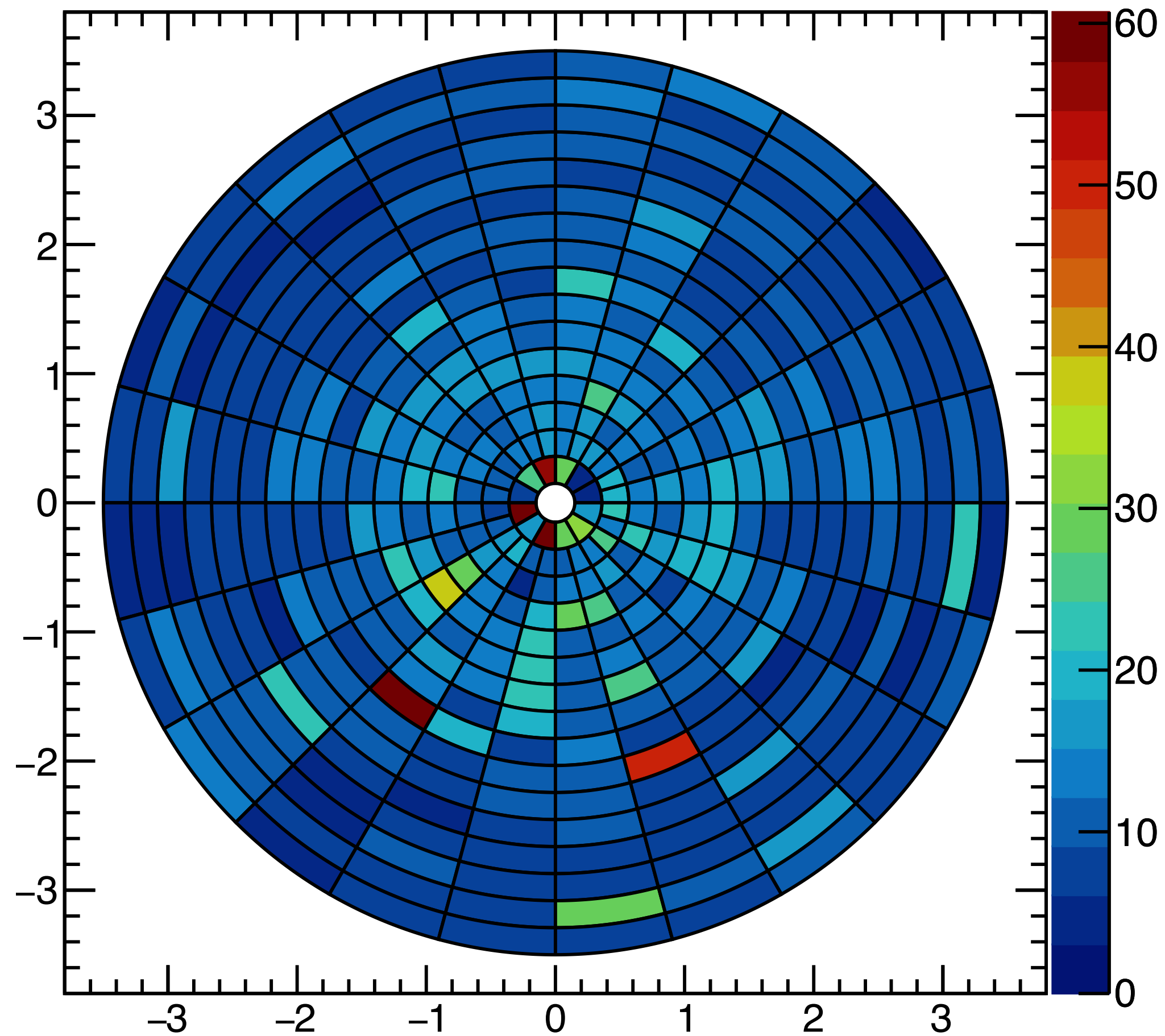
Run 43882 (after ~5-6 hours of store)

Run 43889 (end of store)

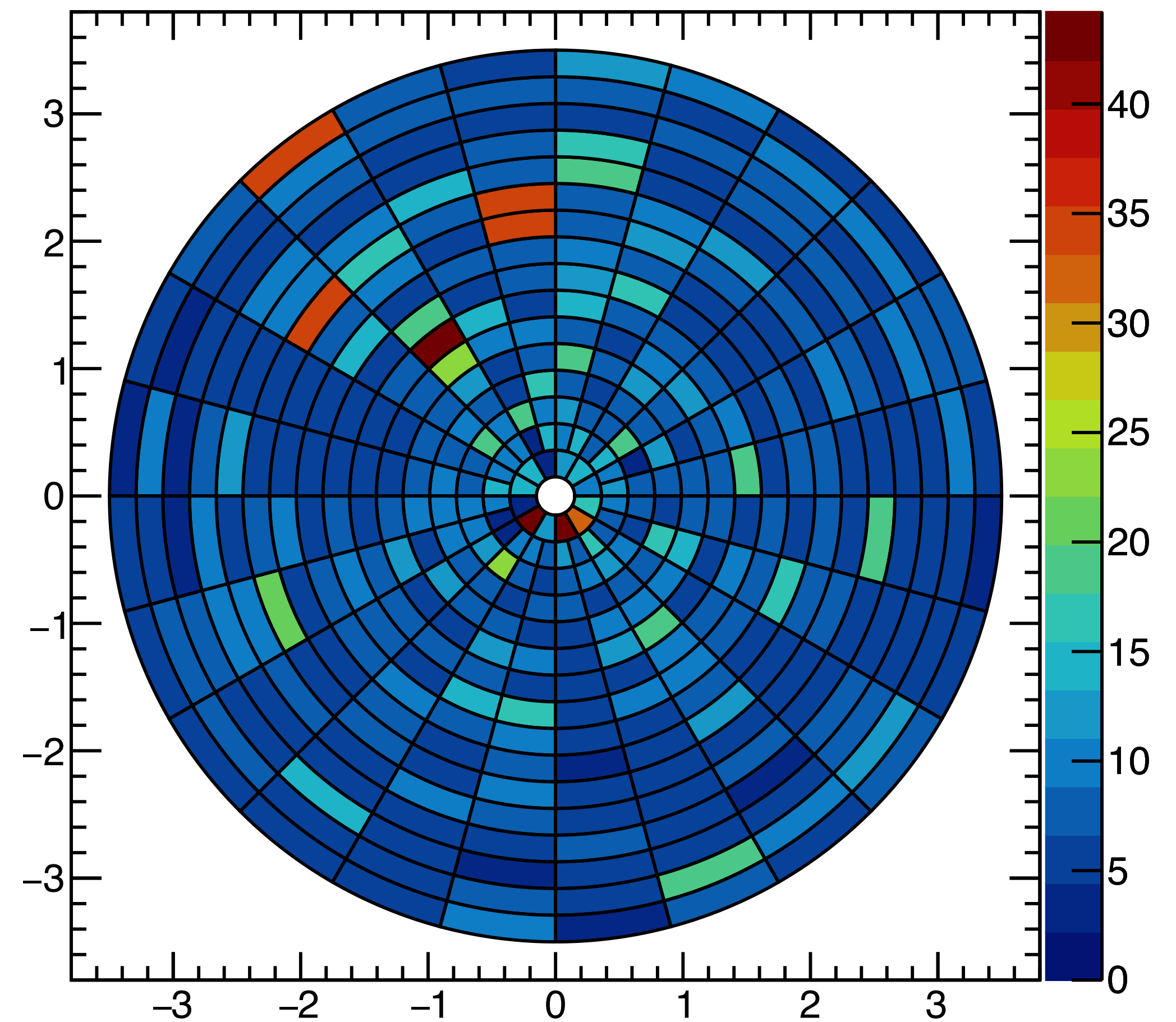


## Run 43853 physics (beginning of store)

*sPHENIX* Internal, Run 43853, sEPD South

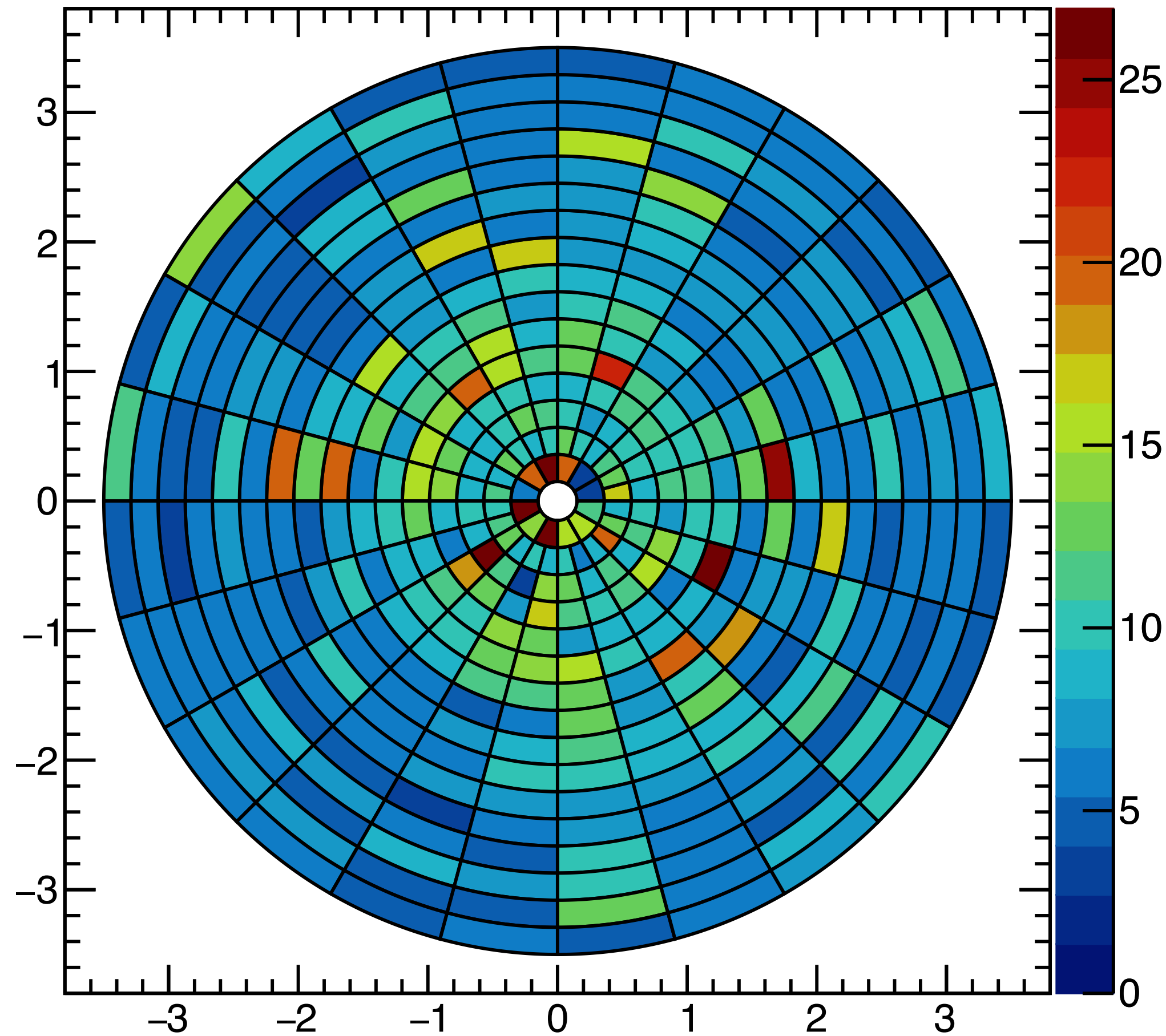


*sPHENIX* Internal, Run 43853, sEPD North

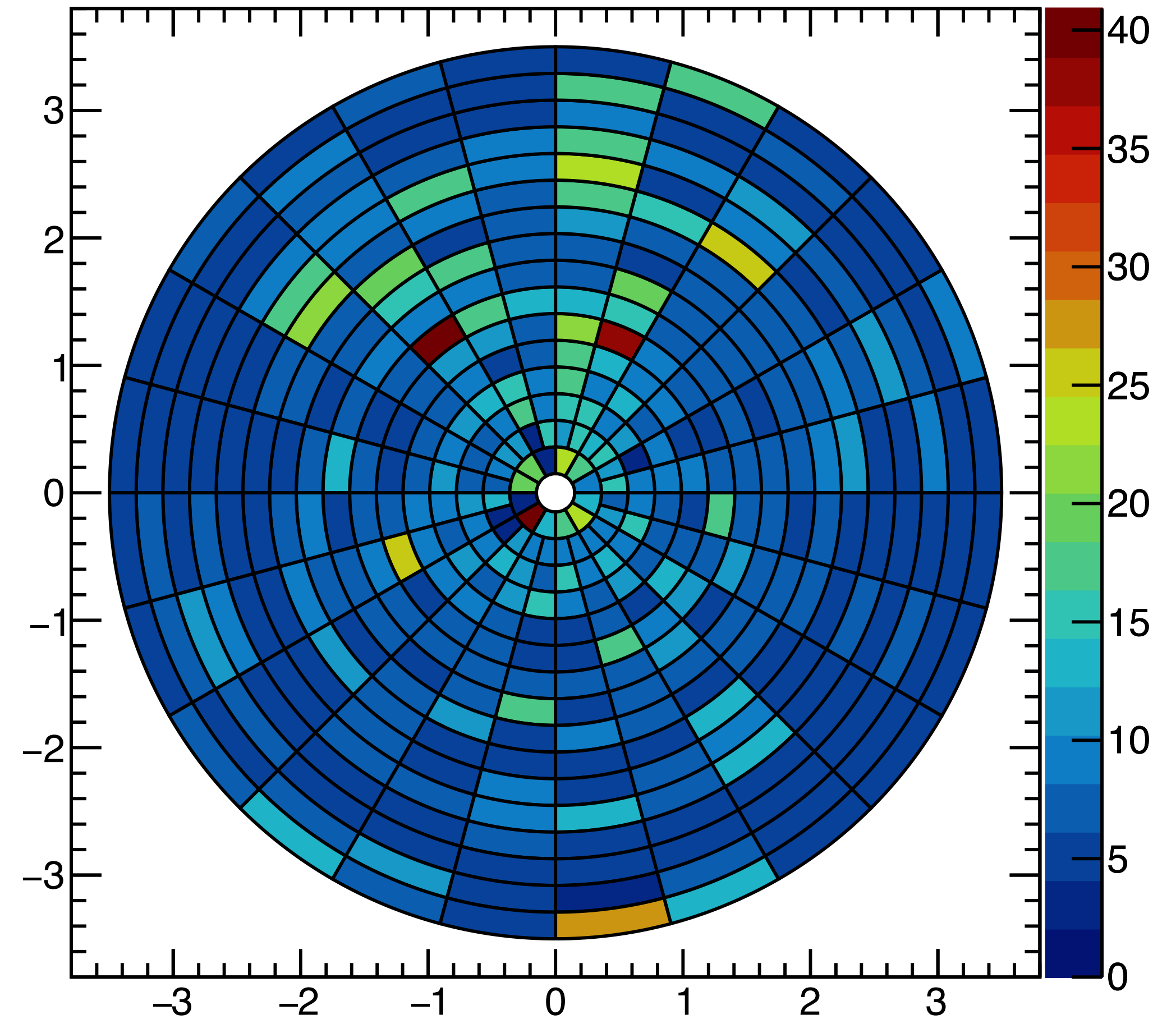


## Run 43882 physics (after ~5-6 hours of store)

*sPHENIX* Internal, Run 43882, sEPD South

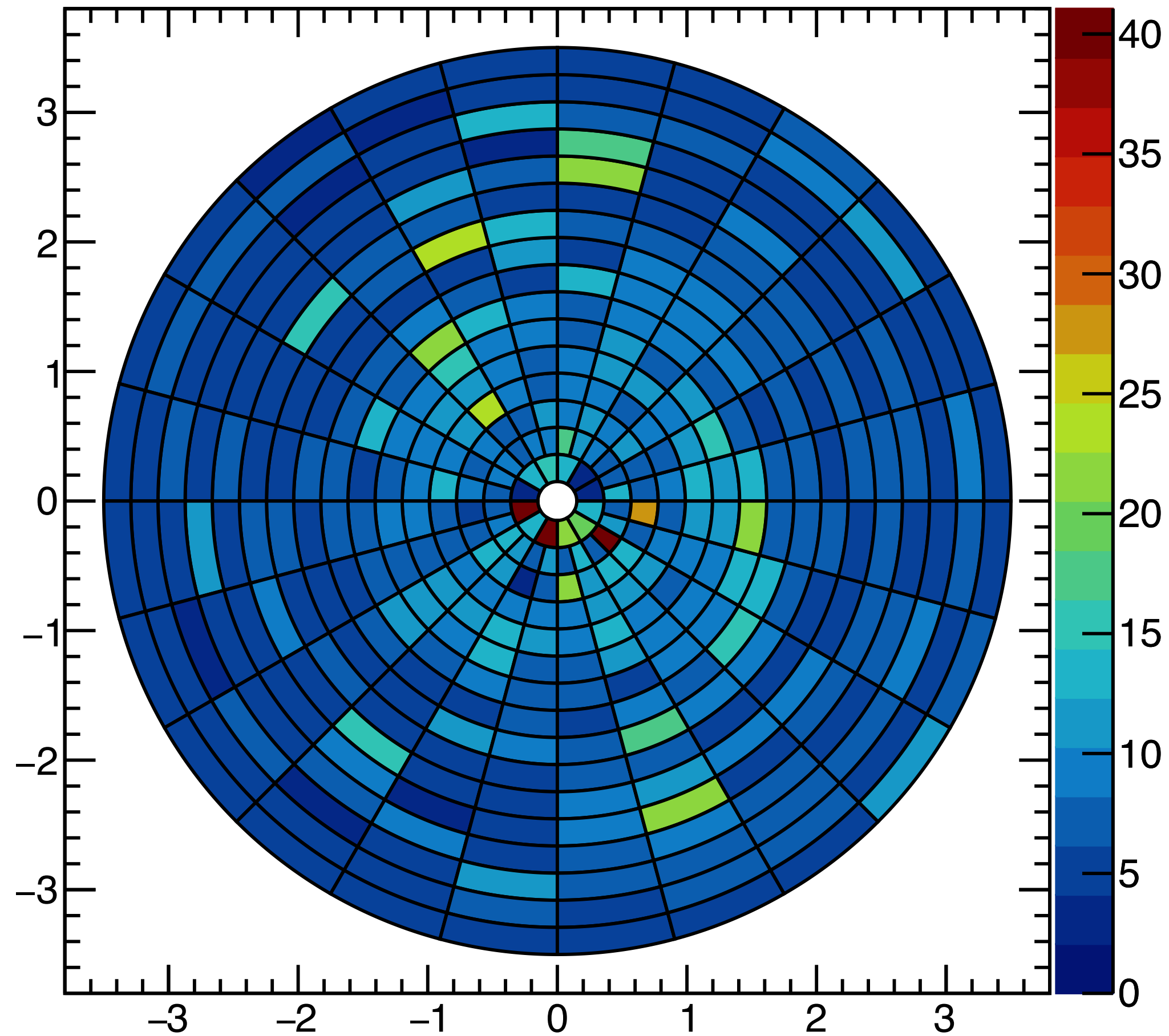


*sPHENIX* Internal, Run 43882, sEPD North



## Run 43889 physics (end of the store)

*sPHENIX* Internal, Run 43889, sEPD South



*sPHENIX* Internal, Run 43889, sEPD North

